System Modeling Techniques for PRA P-200

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System Modeling Techniques for PRA P-200

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Course Outline

Tuesday - AM

0. Introduction (9)

1. Basics (20)

2. Fault Trees (34)

Tuesday - PM

FT Practice examples

3. System Models (26)

Workshop (Appendix A)

Wednesday - AM

4. Uncertainties (22)

5. Event Trees (18) practice example

Sequence Models (17) practice example Wednesday - PM

7. Common Cause Failure Models (36)

Workshops – ET & Sequence Logic (cutsets)

Thursday - AM

8. Quantifying Logic Models (29)

9. Data Analysis (14)

10. Human Error Modeling (21)

11. Results (16)

Thursday - PM

12. Special Topics (22)

Workshops - Cutsets, Quant., and CCF

Friday – AM

Questions/Review

Exam



Course Objectives

- Build PRA modeling and analysis skills
 - Event tree and fault tree model development
 - Dependent failures and common cause modeling
 - Component failure mechanisms
- Improve understanding of quantification process
- Improve ability to extract key results from a PRA
- Greater familiarity with PRA goals and process
- Aleatory (stochastic) versus Epistemic (state of knowledge) uncertainty



Required Background

- Elementary probability theory
- Probability distribution functions
- Fault Tree basics
- Cut sets
- Event trees
- Boolean Algebra



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- 4. U.S. Nuclear Regulatory Commission, Severe Accident Risks: An Assessment for Five U.S. Nuclear Power Plants, NUREG-1150, 1990.
- 5. American Nuclear Society and the Institute of Electrical and Electronics Engineers, PRA Procedures Guide: A Guide to the Performance of Probabilistic Risk Assessments for Nuclear Power Plants, NUREG/CR-2300, 1983.
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- 9. C. L. Atwood, et al., Handbook of Parameter Estimation for Probabilistic Risk Assessment, NUREG/CR-6823, 2003.
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- 11. W.E. Vesely, et al., Measures of Risk Importance and Their Applications, NUREG/CR-3385, 1983.
- 12. D. Sanzo, et al., Survey and Evaluation of Aging Risk Assessment Methods and Applications, NUREG/CR-6157, 1994.



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- 13. N. Siu, "Risk Assessment for Dynamic Systems: An Overview," Reliability Engineering and System Safety, 43, 43-73(1994).
- 14. A. Mosleh, D. Rasmuson, and F. Marshall, Guidelines on Modeling Common-Cause Failures in PRA, NUREG/CR-5485, 1998.
- 15. F. Marshall, D. Rasmuson, and A. Mosleh, Common Cause Failures Parameter Estimations, NUREG/CR-5497, 1998.
- 16. ASME/ANS RA-Sa-2009, "Standard for Level 1/Large Early Release Frequency Probabilistic Risk Assessment for Nuclear Power Plant Applications," Addendum A to RA-S-2008, ASME, New York, NY, American Nuclear Society, La Grange Park, Illinois, February 2009.
- 17. ANS, External-Events PRA Methodology, ANSI/ANS-58.21-2007, March 1, 2007.



Acronyms

Α	Availability	IE	Initiating Event
AFW	Auxiliary Feedwater	λ	Failure rate
AOV	Air Operated Valve	LCO	Limiting Condition of Operation
APB	Accident Progression Bins	LOCA	Loss of Coolant Accident
APET	Accident Progression Event Tree	LOP	Loss of Power
AUTO	Automatic reactor trip	LOSP	Loss of Off-Site Power
ВС	Boundary Conditions	LPI	Low Pressure Injection
CCF	Common Cause Failures	LPR	Low Pressure Recirculation
CCW	Component Cooling Water	LT	Long Term
CV	Check Valve	MACCS	MELCOR Accident Consequence Code System
DG	Diesel Generator	MAN	Manual reactor trip
ECCS	Emergency Core Cooling System	MDP	Motor Driven Pump
ECI	Emergency Coolant Injection	MOV	Motor Operated Valve
ECR	Emergency Coolant Recirculation	NPP	Nuclear Power Plant
EDG	Emergency Diesel Generator	Р	Probability
ET	Event Tree	P&ID	Piping and Instrumentation Diagram
F	Unreliability	PCS	Power Conversion System
FT	Fault Tree	PDF	Probability Density Function
FTR	Fail To Run	PDS	Plant Damage State
FTS	Fail To Start	PL&G	Pickard, Lowe and Garrick
HE	Human Error	PORV	Power-Operated Relief Valve
HPSI	High Pressure Injection System	PRA	Probabilistic Risk Assessment
HRA	Human Reliability Analysis	PSA	Probabilistic Safety Analysis



Acronyms (cont.)

Q Probability (of failure)

R Reliability
Rx Reactor

SIS Safety Injection Signal SLOCA Small break LOCA

SPAR Standardized Plant Analysis Risk Model

ST Short Term

SWS Service Water System
T&M Testing and Maintenance

t time Train

Trans Transient initiating event

System Modeling Techniques for PRA

Lecture 1 - PRA Basics





Objective

- Review of basic concepts of PRA
- Review basic structure of a PRA
- Section Outline
 - Risk
 - System models for PRA
 - Probability vs. Frequency
 - Reliability vs. Availability
 - PRA structure for nuclear power plants
 - Elements of Level 1 PRA



Some Common Terms

- Conservative versus Non-Conservative
- Cutsets
 - Minimal and Non-Minimal
- Core Damage and Large Early Release
- PRA and PSA
- Accident Sequence versus Accident Scenario
- Complimented Events



Definition of Risk

- Formal (vector) definition used in NPP PRA (risk triplet):
 - Risk = {scenario_i, probability_i, consequences_i}
 - Multiple scenarios contribute to risk
 - Consequence can be a vector
 - e.g., different health effects (early fatalities, latent cancers, etc.)
- Commonly used scalar form:
 - Risk = probability x consequences (CDP)or
 - = frequency x consequences (CDF)
- Note that the consequence can be just about anything, even just "core damage"
 - Therefore, core damage frequency is a risk metric



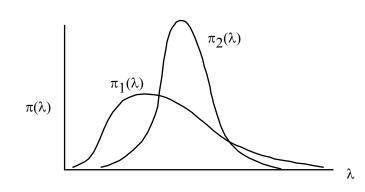
"Scenario" Defined in Terms of Cut Sets

- A cut set is a combination of events that cause the "top event" to occur
 - Top Event = Core Damage (consequence)
- Minimal cut set is the smallest combination of events that causes to top event to occur
- Each cut set represents a failure scenario that must be "ORed" together with all other cut sets for the top event when calculating the total probability of the top event



Probability of Frequency Formalism

- Aleatory Uncertainty
 - Also known as stochastic and random uncertainty
 - Irreducible, given model of world
 - Characterized by (assumed) model parameters
- Epistemic Uncertainty
 - Also known as state-of-knowledge uncertainty
 - Reduces as data accumulates
 - Quantified by probability distributions





Common PRA Models

- Uncertainty in occurrence time of event aleatory
 - Binomial
 - P{r failures in N trials $|\phi|$ } = $\frac{N!}{r!(N-r)!} \phi^r (1-\phi)^{N-r}$
 - Probability of failure for a single demand
 - P{1 failure in 1 trial $| \phi \rangle = \phi$
 - Poisson
 - P{r failures in (0,T) | λ } = $\frac{(\lambda T)^r}{r!}$ e^{- λ T}
 - Probability of one or more failures => Exponential
 - $P\{T_f < t \mid \lambda\} = 1 e^{-\lambda t} \approx \lambda t$ (for small λt)
 - Note that P(1 or more failures) = 1 P(zero failures)
- Uncertainty in rate of occurrence (i.e., on λ and φ) epistemic
 - Lognormal
 - Other (e.g., Gamma, Beta, Maximum Entropy)



Probability and Frequency

- Probability
 - Internal measure of certainty about the truth of a proposition
 - Always conditional
 - Unitless
 - Value between zero and 1.
 - Used for all events in a PRA except the initiating event
- Frequency
 - Parameter used in model for aleatory uncertainty
 - Units of per-demand or per-unit-of-time
 - Time-based frequencies can be any positive value (i.e., can be greater than one)
 - Only used for initiating events and failure rates
- Different concepts; sometimes numerically equal



Probability and Frequency Example

- Frequencies (failure rates)
 - 1x10⁻³ failures/demand (binomial)
 - 1x10⁻⁴ failures/operating hours (Poisson)
- Frequencies converted to probabilities based on a specified mission (i.e., probability of successfully completing mission)
 - P(pump fails to start on demand)
 - P{1 failure | 1 demand} = $(\frac{1!}{1!0!})(10^{-3})^1(1-10^{-3})^0 = 10^{-3}$
 - P{pump fails to run for 24 hours}
 - P{failure time < 24 hours} = $1-e^{-(1E-4)(24)} = 2.4E-3$



Reliability (R)

- Dictionary Definition:
 - Reliability ~ dependability, trustworthiness, repeatability
- Reliability Engineering/PRA Usage:
 - Reliability = Probability a component or system performs its intended function adequately over a given time interval, i.e., for a mission time t

$$R(t) = P\{T_f > t\}$$

where T_f is the time to failure

In other words, likelihood that component survives past mission time



Reliability (R)

- Note:
 - Reliability is a formal, quantitative measure
 - Concept does not address repair of component/system
 - Unreliability: F(t) = 1 R(t)



Availability (A)

- Dictionary Definition
 - Availability ~ state of being capable for use in accomplishing a purpose
- Reliability Engineering/PRA Usage
 - Availability = Probability a component or system is able to perform its intended function at a given point in time, i.e.,
 - $A(t) = P\{X(t) = 1\}$
 - where:
 - -X(t) = 1, component is "good"
 - -X(t) = 0, component is "failed"



Availability (A)

- Note:
 - Concept allows for repair of component/system
 - Unavailability: Q(t) = 1 A(t)
 - Average unavailability:

Qave =
$$\frac{1}{T} \int_{0}^{T} Q(t)dt$$



Common Pitfall

- Confusion of frequency and probability
 - Example: SLOCA and subsequent LOSP

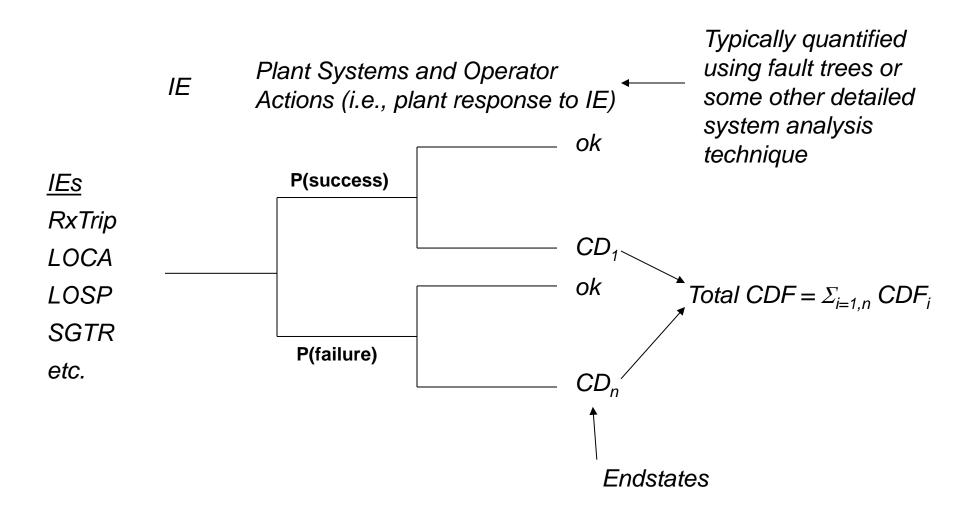
$$\lambda_{SLOCA~\&~LOSP} \neq \lambda_{SLOCA}~X~\lambda_{LOSP}$$

If λ_{SLOCA} = 1E-3/year and λ_{LOSP} = 1E-2/year

What is: frequency of SLOCA and subsequent LOSP?

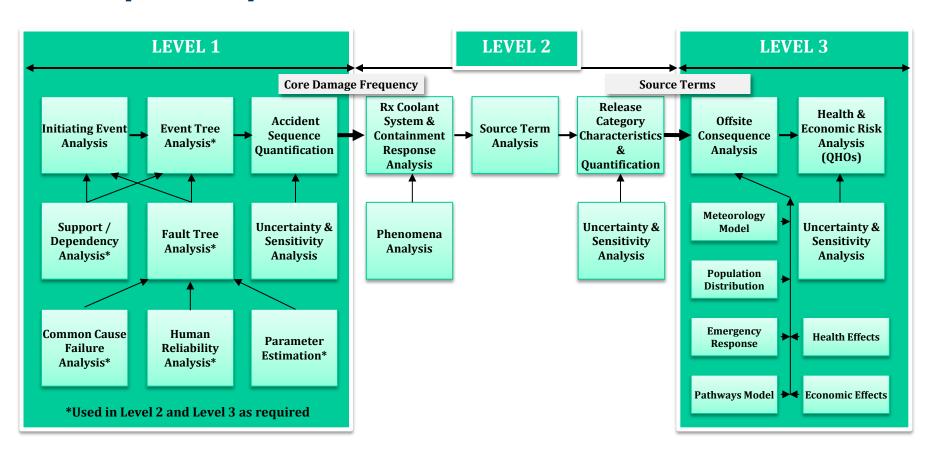


Level-1 PRA (Internal Events Analysis)



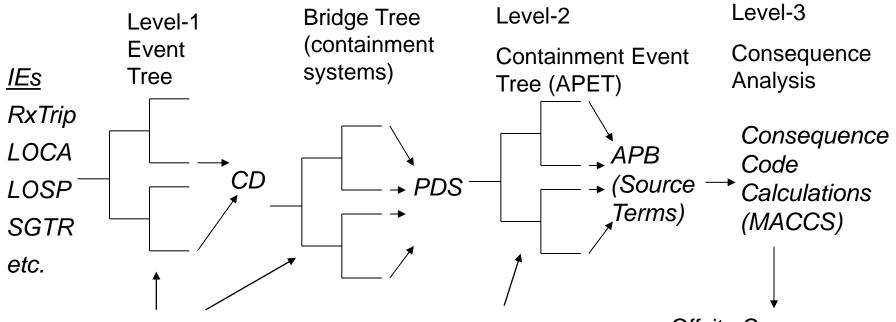


Principal Steps in PRA





Overview of Level-1/2/3 PRA



Plant Systems and Human Action Models (Fault Trees and Human Reliability Analyses)

Severe Accident
Progression
Analyses
(Experimental and
Computer Code
Results)

Offsite Consequence Risk

- Early Fatalities/year
- Latent Cancers/year
- Population Dose/year
- Offsite Cost (\$)/year
- etc.



Risk Example - Death Due to Accidents

- Societal Risk = 130,557 Accidental-Deaths/year
- Average Individual Risk
 - = (139,557 Accidental-Deaths/Year)/316,128,180 Est. U.S. Pop.
 - = 4.1E-04 Accidental-Deaths/Person-Year
 - ≈ 1/2,421 Accidental-Deaths/Person-Year
- In any given year, approximately 1 out of every 2,421 people in the entire U.S. population will die from an accidental death
 - Note: Figures presented above are based on the National Vital Statistics Reports, Deaths: Preliminary Data for 2013, December 2014, Volume 64, Number 2, at www.cdc.gov which is the Centers for Disease Control and Prevention (CDC) National Center for Health Statistics (NCHS) for the United States.
 - Unintentional injuries is the preferred term to accidental deaths in the public health community.
 - The average individual risk for accidental deaths in the 1980s was approximately 5.0E-04 Deaths/Person-year.



Risk Example - Death Due to Cancer

- Societal Risk = 584,881 Cancer-Deaths/year
- Average Individual Risk
 - = (584,881 Cancer-Deaths/Year)/ 316,128,180 Est. U.S. Pop.
 - = 1.9E-03 Cancer-Deaths/Person-Year
 - ≈ 1/540 Cancer-Deaths/Person-Year
- In any given year, approximately 1 out of every 540 people in the entire U.S. population will die from cancer
 - Note: Figures presented above are based on the National Vital Statistics Reports, Deaths: Preliminary Data for 2013, December 2014, Volume 64, Number 2, at www.cdc.gov which is the Centers for Disease Control and Prevention (CDC) National Center for Health Statistics (NCHS) for the United States.
 - Malignant neoplasms is the preferred term to cancer deaths in the public health community.
 - The average individual risk for cancer deaths in the 1980s was approximately 2.0E-03 Deaths/Person-year.



NRC Quantitative Health Objectives (QHOs)

- Originally known as the Probabilistic Safety Goals
 - NRC adopted two probabilistic safety goals on August 21, 1986
- High-level goal: incremental risk from nuclear power plant operation < 0.1% of all risks
 - Average individual (within 1 mile of plant) early fatality (accident) risk
 5E-7/year
 - Average individual (within 10 miles of plant) latent fatality (cancer) risk
 < 2E-6/year
- Lower level subsidiary goals were derived from the high-level QHOs
 - Frequency of significant core damage (CDF) < 1E-4/year
 - Frequency of large early release of fission products from containment (LERF) <
 1E-5/year
- Metrics for new reactors (SRM on SECY-90-016, 6/26/90)
 - CDF < 1E-4/year</p>
 - Large release frequency (LRF) < 1E-6/year
 - Conditional containment failure probability (CCFP) < 0.1

System Modeling Techniques for PRA

Lecture 2 - Fault Trees





Objectives

- Review of fault tree basics
- Develop understanding of:
 - When to use fault trees
 - Construction techniques
 - How to solve fault trees
 - How to quantify fault trees



Outline

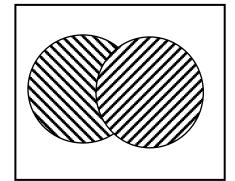
- Boolean Algebra
- Basic Elements of a Fault Tree
- When to use a Fault Tree Model
- Cut sets
- Fault Tree construction
- Cut set generation



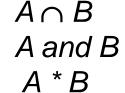
Basic Probability Concepts Used in PRAs

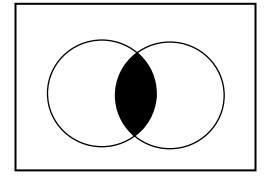
Venn Diagrams

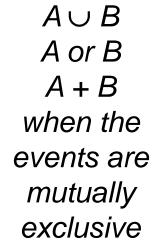
 $A \cup B$ A or BA + B



 $A \cap /B$ A and /BA * /B











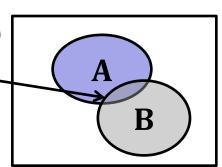
Manipulating Probabilities

- Rules for the OR Operation
 - In general, if A, B are not disjoint (not mutually exclusive)
 - Pr(A or B) = Pr(A) + Pr(B) Pr(A AND B)
 - Can extend to three or more events
 - If A, B are disjoint (mutually exclusive)
 - Pr(A or B) = Pr(A) + Pr(B)
 - Example:
 with a die, Pr(1 or 2) = Pr(1) + Pr(2)
 because outcomes are disjoint



- If A, B are independent
 - Pr(A AND B) = Pr(A) Pr(B) (definition)
- If A, B are not independent (i.e., dependent)
 - $Pr(A \text{ AND B}) = Pr(A) \cdot Pr(B|A)$ = $Pr(B) \cdot Pr(A|B)$

- g, given that A occurs,"
- Pr(B|A) read as "probability of B occurring, given that A occurs," or more simply, "probability of B, given A"
- The "|" is statistical shorthand for "given that"





Basic Probability Concepts

• Independent:

- Means that the occurrence (or non-occurrence) of an event (such as A) has no influence on the subsequent occurrence (or non-occurrence) of another event (such as B) and vice versa
- If a fair coin is tossed randomly, the occurrence of Heads on the first toss should not influence the probability of Tails on the second toss.
- This property allows us to write:
 - If A and B are two independent events, then Pr(A and B) = Pr(A) * Pr(B).
 - Example: Pr(H and T | two tosses) = Pr(H) * Pr(T)

Mutually Exclusive:

- Means that events (such as A and B) cannot both happen on a single trial of an experiment
- With the toss of a fair coin, either a Head or a Tail is the expected outcome, cannot possibly get both a Head and a Tail as an outcome on a single toss
- This property allows us to write:
 - If A and B are two mutually exclusive events, the Pr(A or B) = Pr(A) + Pr(B)
 - If Mutually Exclusive, Pr(A and B) = Pr(A)*Pr(B|A) = Pr(B)*Pr(A|B) = 0
 - Example: Pr(H or T | one toss) = Pr(H) + Pr(T) ∴ Pr(H and T | one toss) =



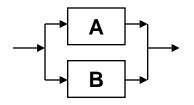
Basic Probability Concepts

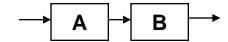
- Dependent
 - Means that the occurrence (or non-occurrence) of an event (such as A) has an influence on the subsequent occurrence (or non-occurrence) of another event (such as B) and vice versa
 - For example, if a resistor overheats in an electronic circuit, it may very well change the failure probability of a nearby transistor or related circuitry.
 - This property allows us to write
 - If A and B are two mutually interdependent events, then Pr(A and B) = Pr(A) *
 Pr(B|A) = Pr(B) * Pr(A|B)
 - Term Pr(B|A) represents the probability of B given that A has happened
 - Note: if they are independent then Pr(B|A) = Pr(B) and Pr(A|B) = Pr(A)
- Complement (or "not")
 - Means the probability is "1 -" the probability of event
 - Pr(not A) = 1 Pr(A)
- Conditional probability definition
 - In general = $Pr(A \text{ AND B}) = Pr(A) \cdot Pr(B \mid A)$
 - The conditional probability is last term, Pr(B | A), so
 - $Pr(B \mid A) = Pr(A \text{ AND B}) / Pr(A), Pr(A) \neq 0$
 - $Pr(A \mid B) = Pr(A \text{ AND B}) / Pr(B), Pr(B) \neq 0$



Simple FT logic illustration

- Two components in parallel (redundant)
 - Both need to fail to fail the system
 - P(system failure) = P(A) * P(B)
- Two components in series
 - Any one failure, fails the system
 - P(system failure) = P(A) + P(B)

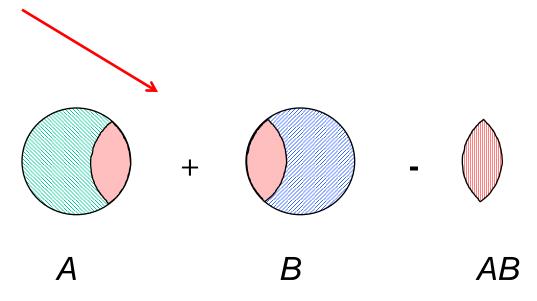


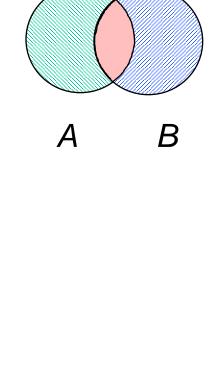




Summing Probabilities

- Need to account for the "double-counting of the overlap of the two events
- P(A+B) = P(A) + P(B) P(AB)





 Extends to higher order number of events as well.



Rules of Boolean Algebra

Mathematical Symbolism E	Engineering Symbolism	Designation
(1a) $X \cap Y = Y \cap X$ (1b) $X \cup Y = Y \cup X$	X * Y = Y * X X + Y = Y + X Algebra	Commutative Law
(2a) $X \cap (Y \cap Z) = (X \cap Y) \cap Z$ (2b) $X \cup (Y \cup Z) = (X \cup Y) \cup Z$	X * (Y * Z) = (X * Y) * Z X(YZ) = (XY)Z X + (Y + Z) = (X + Y) + Z	Associative Law
(3a) $X \cap (Y \cup Z) = (X \cap Y) \cup (X \cap Z)$ (3b) $X \cup (Y \cap Z) = (X \cup Y) \cap (X \cup Z)$	X * (Y + Z) = (X * Y) + (X * Z) X(Y+Z) = XY + XZ X + (Y * Z) = (X + Y) * (X + Z)	Distributive Law
(4a) $X \cap X = X$ (4b) $X \cup X = X$ Important!	$\begin{array}{c} X * X = X \\ X + X = X \end{array}$ Important	Idempotent Law
(5a) $X \cap (X \cup Y) = X$ (5b) $X \cup (X \cap Y) = X$ Important!	X * (X + Y) = X X + X * Y = X During Cut Set Generation	Law of Absorption
(6a) $X \cap X' = \Phi = 0$ (6b) $X \cup X' = \Omega = I$ (6c) $(X')' = X$	$X * /X = \Phi = 0$ $X + /X = \Omega = I$ /(/X) = X	Complementation
(7a) $(X \cap Y)' = X' \cup Y'$ (7b) $(X \cup Y)' = X' \cap Y'$	/(X * Y) = /X + /Y /(X + Y) = /X * /Y	DeMorgan's Theorem



Boolean Algebra Exercises

Simplify:

$$T1 = (A + B) * (B + C).$$

 $T2 = (D + E) * (/D + E).$

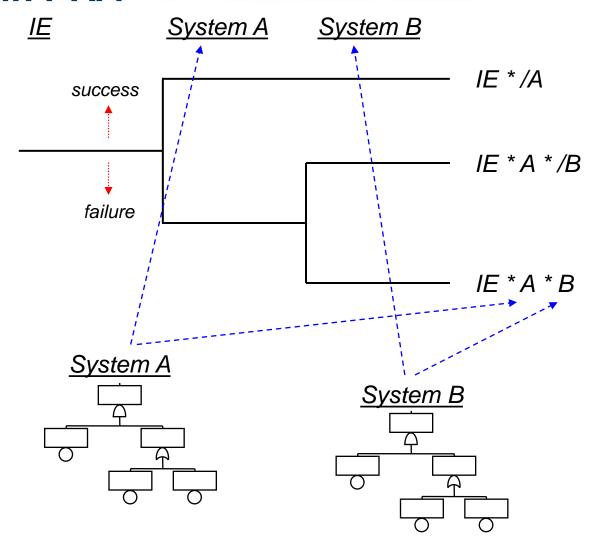


Fault Trees and Event Trees

- Basic modeling tools in PRA
- Event Tree used for "high-level" sequence of events
 - Typically (but not necessarily) chronological
- Most high-level events on ET modeled in detail using fault trees
 - Fault trees often referred to as "system" models



FT & ET in PRA





Method Selection

- Consider event trees when:
 - Interested in consequences of an initiating event
 - Inductive reasoning
 - Multiple barriers, sequential challenges
 - Multiple outcomes of interest
 - Process-oriented users
- Consider fault trees when:
 - Interested in causes of an event
 - Deductive reasoning
 - Single top event of interest



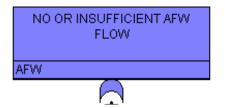
Method Selection (cont.)

- Consider other methods (e.g., analytical methods, Markov models, dynamic event trees, direct simulation) when:
 - Time dependence is important
 - Process dynamics strongly affect sequence development and likelihood



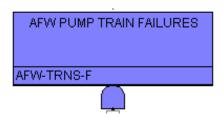
Basic Fault Tree Symbols

Symbol Description



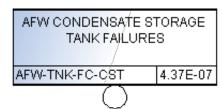
"OR" Gate

Logic gate that implies any of the inputs is sufficient to produce an output (i.e., propagate up through the gate). The probability of an output from this gate is the sum of the probabilities of all the inputs to this gate.



"AND" Gate

Logic gate that implies all of the inputs must occur for the output to occur. The probability of an output from this gate is the product of the probabilities of all of the inputs to this gate.



Basic Event

Identifies the lowest (most basic) type of event in the fault tree. There is no further development (i.e., fault tree logic) below a basic event beyond assigning the basic event probability (by the analyst).

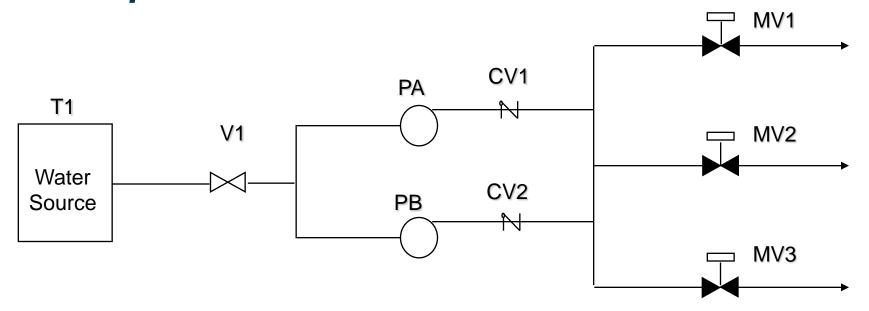


Basic Fault Tree Symbols (cont.)

Symbol Description A fault event whose development is limited due BE 4 Undeveloped to insufficient consequence or lack of additional detailed information. That is, in the PRA it is **Event** represented as just a probability, no logic. BE4 2.4590E-02 Symbol used to show there is additional logic under this event, but that logic is developed elsewhere in the PRA. Sometimes used to account for support system dependencies (i.e., the support system fault tree exists in the PRA, but is not explicitly reproduced every time it is FAILURE OF 2400 VAC BUS 1E Transfer Gate DIV-E-AC needed). Logical True (or False) event in the fault tree logic. Note that this is different from just setting an event propability to 1 or zero. Used to model HOUSE EVENT: LOSS OF DIVE House OFFSITE POWER FLAG **Event** changes in plant system status. False HE-LOSP-E Logic gate providing a representation of the Boolean union of input events. The output will occur if at least N of the M number of inputs DHR SYSTEM HARDWARE N-of-M FAILURES. occur. SDC-SYS-F



Example Cut Sets - ECI



Success Criteria: Flow from any one pump through any one MV

T tank

V_ manual valve, normally open

PS-_ pipe segment

P_ pump

CV check valve

MV_ motor-operated valve, normally closed

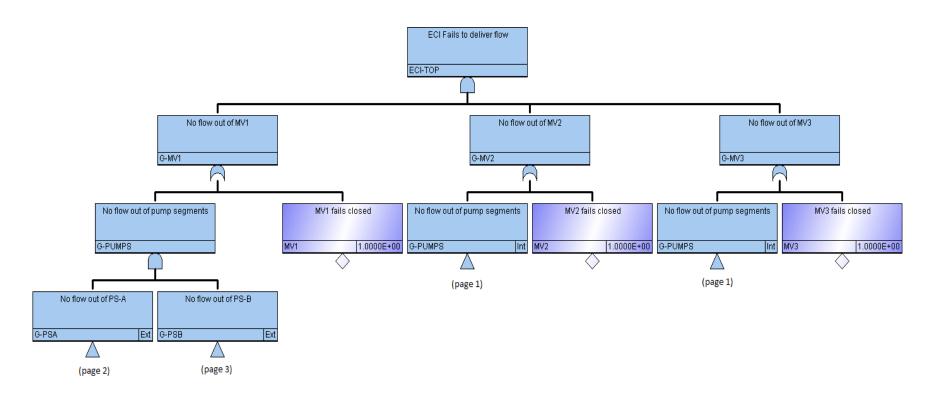


Two Common Fault Tree Construction Approaches

- "Sink to source"
 - Start with system output (i.e., system sink)
 - Modularize system into a set of pipe segments (i.e., group of components in series)
 - Follow reverse flow-path of system developing fault tree model as the system is traced
- Block diagram-based
 - Modularize system into a set of subsystem blocks
 - Develop high-level fault tree logic based on subsystem block logic (i.e., blocks configured in series or parallel)
 - Expand logic for each block

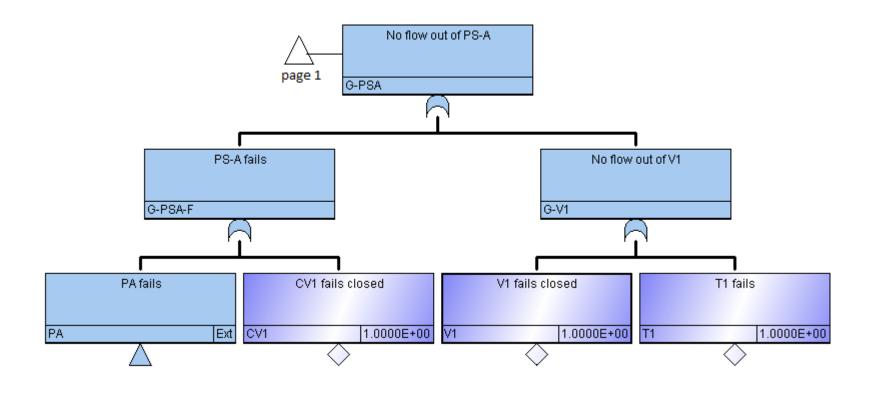


ECI System Fault Tree - Reverse Flow (page 1)



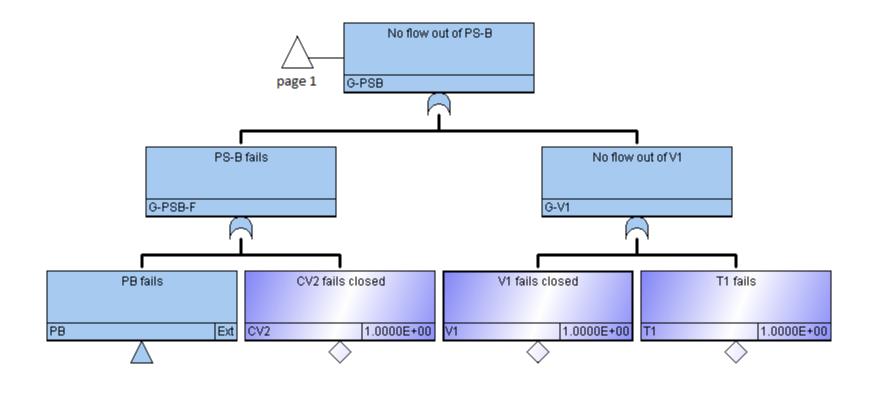


ECI System Fault Tree (page 2)



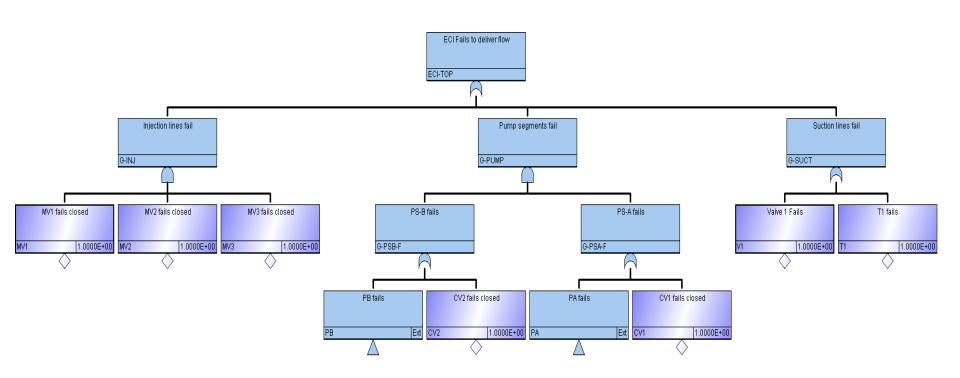


ECI System Fault Tree (page 3)





ECI System Fault Tree (block diagram method)





Cut Sets by Boolean Expansion of Fault Tree

```
ECI-TOP = G-MV1 * G-MV2 * G-MV3.
                                                                   Start substituting
ECI-TOP = (MV1 + G-PUMPS) * (MV2 + G-PUMPS) * (MV3 + G-PUMPS)
                                                                Keep substituting and performing Boolean algebra
                                                                   (e.g., X*X = X)
ECI-TOP = (MV1 * MV2 * MV3) +
   (MV1 * MV2 * G-PUMPS) +
   (MV1 * G-PUMPS * MV3) +
   (MV1 * G-PUMPS * G-PUMPS) +
   (G-PUMPS * MV2 * MV3) +
   (G-PUMPS * MV2 * G-PUMPS) +
   (G-PUMPS * G-PUMPS * MV3) +
   (G-PUMPS * G-PUMPS).
ECI-TOP = (MV1 * MV2 * MV3) +
   (MV1 * MV2 * G-PUMPS) +
   (MV1 * G-PUMPS * MV3) +
   (MV1 * G-PUMPS) +
   (G-PUMPS * MV2 * MV3) +
   (G-PUMPS * MV2) +
   (G-PUMPS * MV3) +
   (G-PUMPS).
ECI-TOP = (MV1 * MV2 * MV3) +
   (G-PUMPS).
```



Cut Sets (cont.)

```
ECI-TOP = (MV1 * MV2 * MV3) +
          (G-PSA * G-PSB).
ECI-TOP = (MV1 * MV2 * MV3) +
          ((G-PSA-F + G-V1) * (G-PSB-F + G-V1)).
ECI-TOP = (MV1 * MV2 * MV3) +
          (G-PSA-F * G-PSB-F) +
          (G-PSA-F*G-V1) +
          (G-V1 * G-PSB-F) +
          (G-V1).
ECI-TOP = (MV1 * MV2 * MV3) +
          (G-PSA-F * G-PSB-F) +
          (G-V1).
ECI-TOP = (MV1 * MV2 * MV3) +
          (PA + CV1) * (PB + CV2) +
          (V1 + T1).
ECI-TOP = MV1 * MV2 * MV3 +
          PA * PB +
          PA * CV2 +
          CV1 * PB +
          CV1 * CV2 +
          V1 +
          T1.
```



Specific Failure Modes Modeled for Each Component

- Each component associated with a specific set of failure modes/mechanisms determined by:
 - Type of component
 - E.g., Motor-driven pump, air-operated valve
 - Normal/Standby state
 - Normally not running (standby), normally open
 - Failed/Safe state
 - Failed if not running, or success requires valve to stay open



Typical Component Failure Modes

- Active Components
 - Fail to Start
 - Fail to Run
 - Unavailable because of Test or Maintenance
 - Fail to Open/Close/Operate
 - Definitions not always consistent among PRAs
 - e.g., transition from start phase to run phase can be defined differently (load/run)

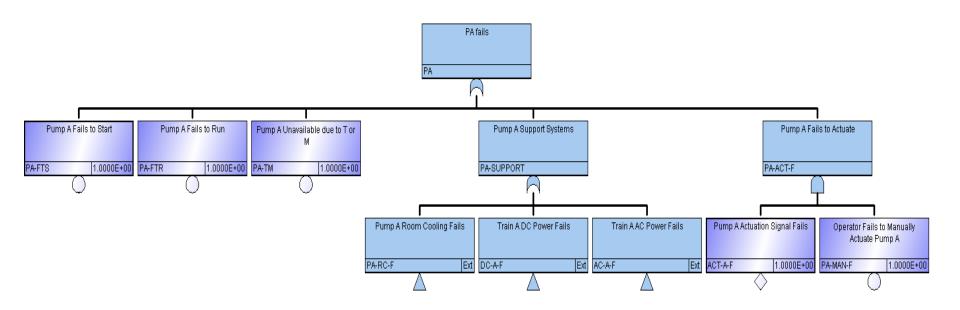


Typical Component Failure Modes (cont.)

- Passive Components
 - Rupture
 - Plugging (e.g., strainers/orifice)
 - Fail to Remain Open/Closed (e.g., manual valve)
 - Short (cables)
 - Not always modeled in PRAs
 - Implicit assumption
 - P(passive failures) << P(active active)</p>



Example FT for Pump





Component Boundaries

- Typically include all items unique to a specific component, e.g.,
 - Drivers for EDGs, MDPs, MOVs, AOVs, etc.
 - Circuit breakers for pump/valve motors
 - Need to be consistent with how data was collected
 - That is, should individual piece parts be modeled explicitly or implicitly
 - For example, actuation circuits (FTS) or room cooling (FTR)



Active Components Require "Support"

- Signal needed to "actuate" component
 - Safety Injection Signal starts pump or opens valve
- Support systems might be required for component to function
 - AC and/or DC power
 - Service water or component water cooling
 - Room cooling



Support System Dependencies

- Can be modeled at system level, train level or component level
- Dependency matrix is frequently used to document identified dependencies

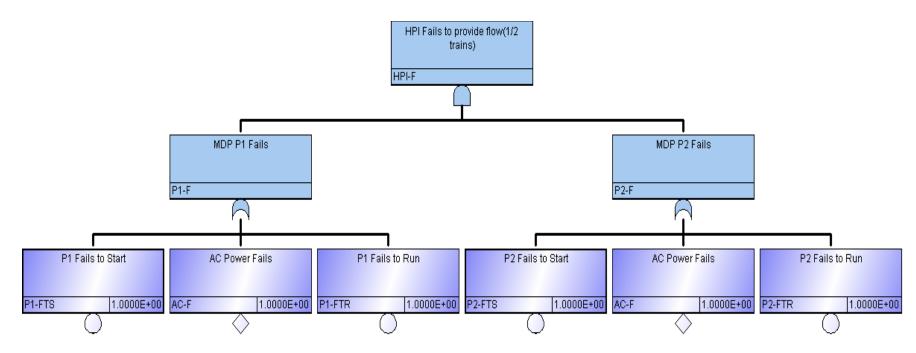
Note: If support system serves more than one component or system, it is modeled separately (see next two slides)



Practice Example HPI Fault Tree

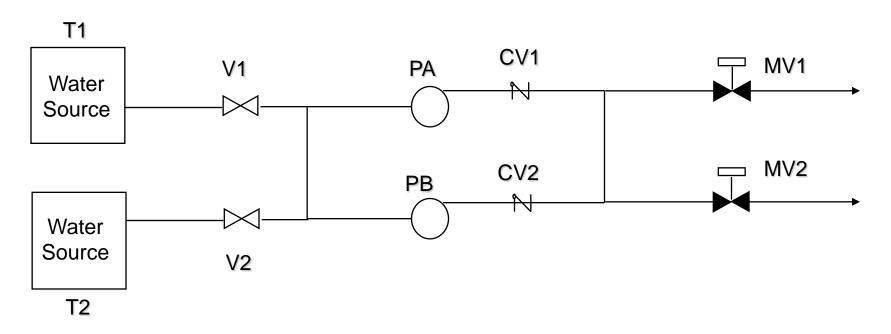
Support System Dependency:

AC power supports both pumps 1 and 2





Practice Example



Success Criteria: One pump flow through both MV's

System Modeling Techniques for PRA

Lecture 3 - System Models





Objective

- Develop understanding of System Modeling, including:
 - Modeling goals
 - Modeling techniques and variations



Outline

- System Modeling Approach
- Missions
- Success Criteria
- Boundary Conditions
- Parallel/Series System Modeling
- System Level Fault Tree Modeling
- Results



System Modeling Approach

- Focus on individual plant systems
- Issues addressed by logic model
 - How can the system fail?
 - How likely is failure?
 - What are the dominant contributors?
- Key questions for understanding the system
 - What does the system do?
 - What is "failure"?
 - What is the "system"?
 - What are the analysis boundaries?



System Mission Affects Model

- Demand based missions (binomial)
 - Normally in standby
 - Required to perform one (or more) times
 - e.g., actuation systems, relief valves
- Time based missions (Poisson)
 - Either in standby or normally operating
 - Required to operate for some length of time, which affects unreliability
 - e.g., ECCS, SWS



Success Criteria

- Needed to employ binary logic modeling
 - Note that same system may be modeled under different conditions for different initiators
- Developed from physical analyses
- Can be sequence-dependent
- Must consider details of expected mission (e.g., mission time, actuation signals, status of support systems)



Analysis Scope and Boundaries

- Plant Operating Mode
- Hardware
 - power supply/powered system
 - common actuation/actuated system
 - cooling system/cooled system
 - cross-ties
- Failure Modes
 - internal vs. "external"
 - errors of commission
- Mission Time
- Organization



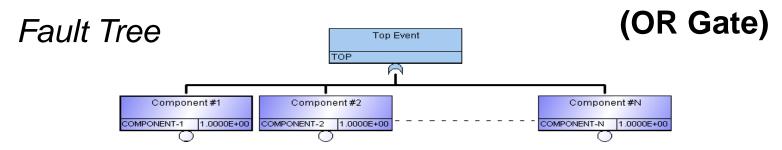
Definition of Problem Must be Specific and Precise

- Sample Success Criteria
 - Improper:
 - HPIS is successful
 - Proper:
 - Uninterrupted flow from 2/3 HPIS pumps for 24 hours
 - Generally defined from thermal-hydraulics calculations



Series System





Boolean and Quantification

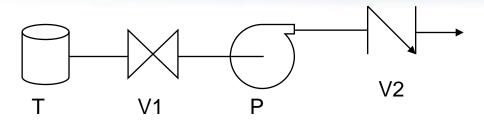
$$Top = \sum_{i=1}^{N} X_{i}$$

$$P\{Top\} = 1 - \prod_{i=1}^{N} (1 - Q_{i}) \quad (if independent)$$

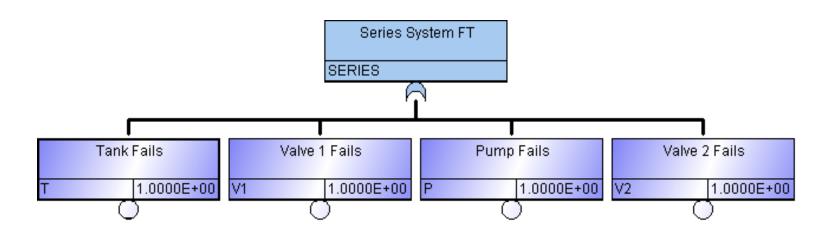
$$\approx \sum_{i=1}^{N} Q_{i} \quad (rare event approximation)$$



Series System Example



Any component failure fails the system

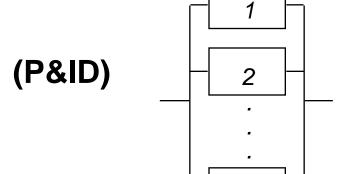




Parallel System



N



Fault Tree

TOP

1.0000E+00

Component #2

COMPONENT-2

Top Event



COMPONENT-N

Component #N

1.0000E+00



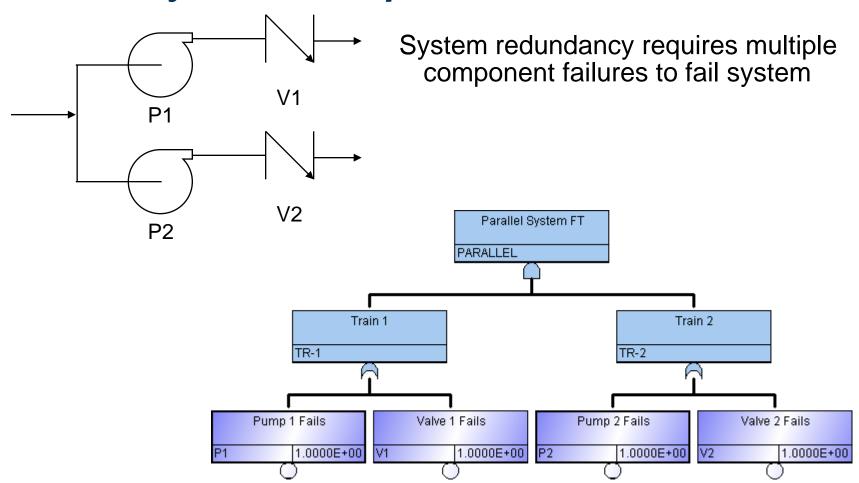
Component #1

1.0000E+00

$$Top = \prod_{i=1}^{N} X_i$$
 (Cut Sets)
 $P\{Top\} = \prod_{i=1}^{N} Q_i$ (if independent)

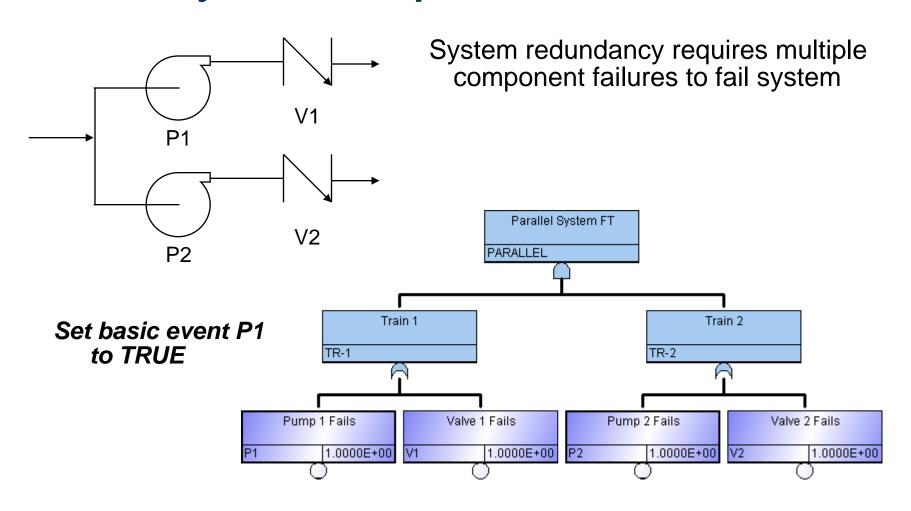


Parallel System Example





Parallel System Example





Fault Tree Construction

- Items to consider
 - Dependent Failures
 - Functional Dependencies
 - Support Systems
 - Shared Equipment Dependencies
 - LPR requires same pumps as LPI
 - Test/Maintenance (T&M) Dependencies
 - Single T&M procedure can make multiple components unavailable
 - Common Cause Failures



Fault Tree Construction (cont.)

- Human errors in fault trees
 - HEs lead to additional basic-events/failure-modes
 - Examples: Fail to restore, failure to initiate, improper termination (rarely modeled)
 - HEs in fault trees are local in scope
- Modeling T&M unavailability can result in illogical cut sets
 - Multiple redundant trains are generally not out at same time
 - Using complemented events (e.g., A_{tm} * /B_{tm}) complicates the quantification
- Putting recovery in FT might give overly optimistic results



Fault Tree Pitfalls

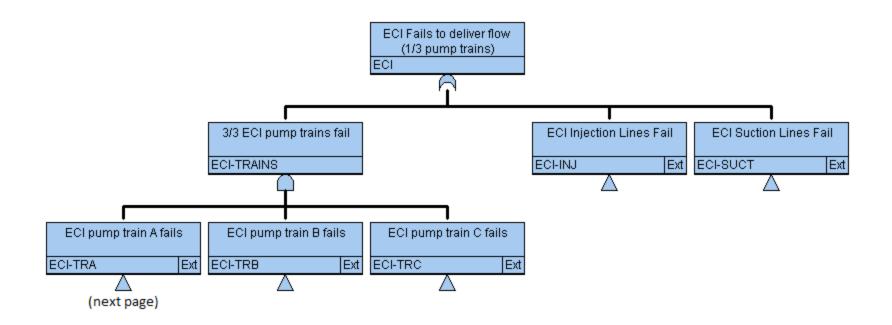
- Inconsistent or unclear basic event names
 - X*X = X, so if X is called X1 in one place and X2 in another place, incorrect results are obtained
- Missing dependencies or failure mechanisms
 - An issue of completeness
- Unrealistic assumptions
 - Availability of redundant equipment
 - Credit for multiple independent operator actions
 - Violation of plant LCO
- Logic loops
 - Will talk about what they are and how to fix them...



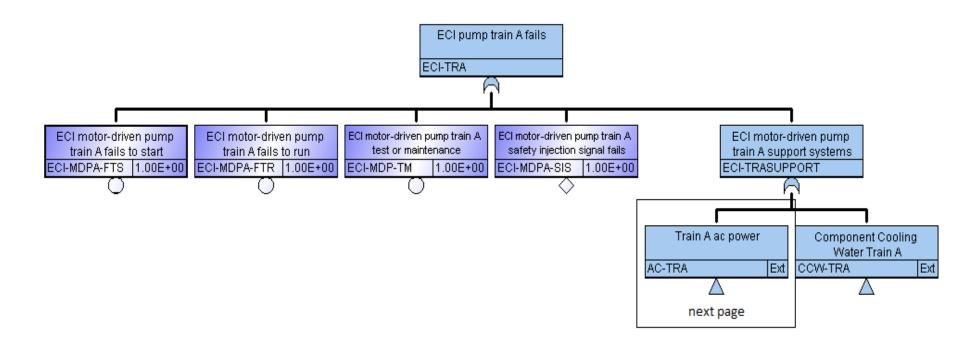
Logic Loops Result From Circular Support Function Dependencies

- ECI pump requires AC power
- AC power supplied from either Offsite Power or Diesel Generators (DGs)
- DGs require Component Cooling Water (CCW) for cooling
- CCW pumps require AC power

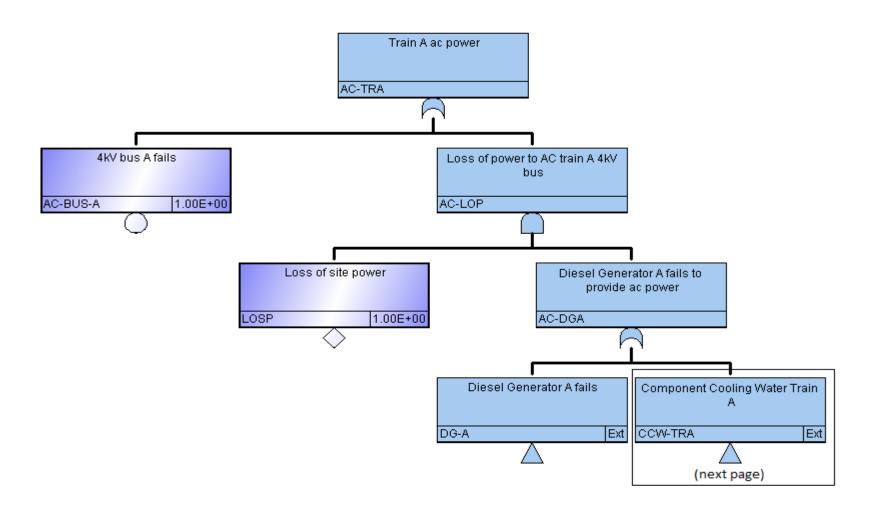




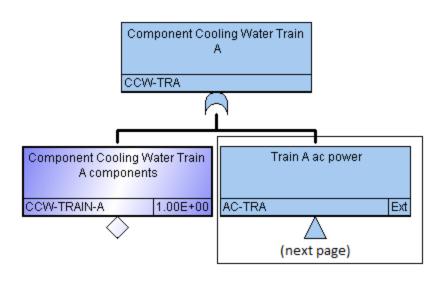




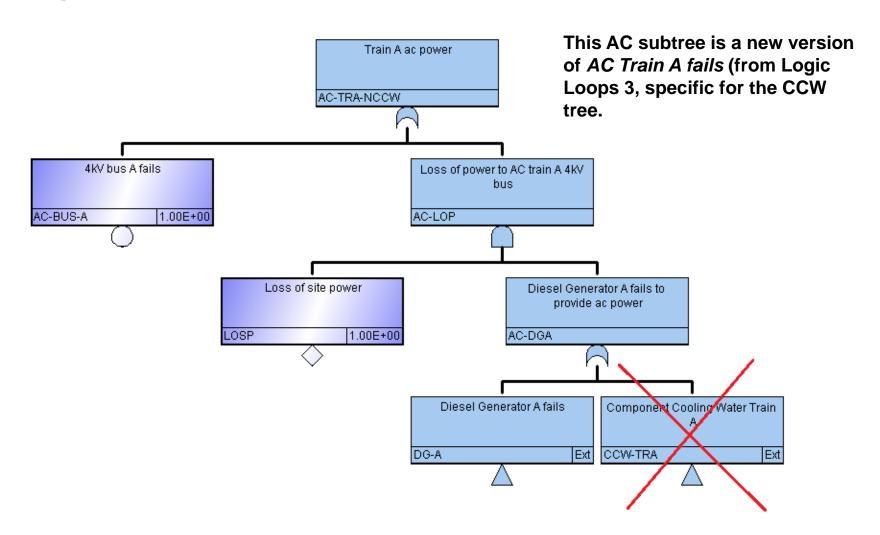






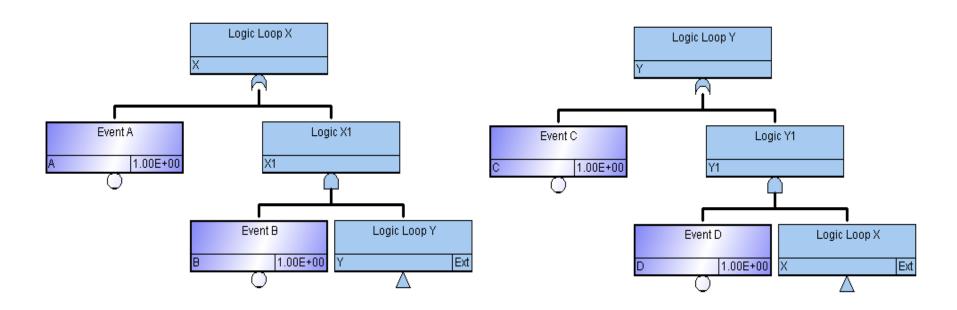








Generate Cut Sets



Idaho National Laboratory

Results

- Sanity checks on cut sets
 - Symmetry
 - If Train-A failures appear, do Train-B failures also appear?
 - Completeness
 - Are all redundant trains/systems really failed?
 - Are failure modes accounted for at component level?
 - Realism
 - Do cut sets make sense (i.e., Train-A out for T&M ANDed with Train-B out for T&M)?
 - Predictive Capability
 - If system model predicts total system failure once in 100 system demands, is plant operating experience consistent with this?



What is Wrong?

```
System XYZ Pumps Fail =
PumpA-FTS * PumpB-FTS +
PumpA-FTS * PumpB-FTR +
PumpA-FTS * PumpB-TM +
PumpA-FTR * PumpB-FTR +
PumpA-FTR * PumpB-FTR +
PumpA-TM * PumpB-FTS +
PumpA-TM * PumpB-FTR +
PumpA-TM * PumpB-FTR +
```



PRA Modeling Mindset

- All systems can fail
 - Under what conditions is failure more likely? How likely are these?
 - Are all potentially significant mechanisms identified and treated?
- Catastrophic system failures are rare events
 - May need creative search for failure mechanisms
 - Maximize use of available information, which implies that Bayesian methods to be used
- System failure is a "systems" issue
 - Need to identify and address systems interactions
 - Avoid drawing analysis boundaries too tightly

System Modeling Techniques for PRA

Lecture 4 – Uncertainty





Objective

- Understand implications of uncertainty associated with PRAs
- Understand different types and sources of uncertainty
- Understand mechanics of how uncertainty is calculated
- Understand why we calculate uncertainty
- Outline
 - Types of uncertainties
 - Uncertainty Measures
 - Propagation of Uncertainties



Stochastic Uncertainties

- Measure of randomness or variability in process
 - e.g., coin flip sometimes heads, sometimes tails
- Also called random or aleatory uncertainty
- Distribution is result of assumptions about a process
 - Failure occur randomly in time (Poisson)
 - Failure occur randomly given a demand (binomial)
- Distribution is a function of parameter values (e.g., failure rate λ), which are uncertain



State-of-Knowledge Uncertainties

- Lack of accuracy in model parameters (i.e., uncertainty in λ's)
- Also called subjective or epistemic uncertainty
- Distribution reflects data, relevant model predictions, engineering judgment
- Typically generated using Bayesian methods (covered in Statistics course)



Uncertainties

- Summary Measures
 - Mean:

$$E[\lambda] = \int_0^\infty \lambda \pi(\lambda) d\lambda$$

Note: $\int_0^\infty \pi(\lambda) d\lambda = 1$

– Variance:

$$E[(\lambda - E[\lambda])^{2}] = \int_{0}^{\infty} (\lambda - E[\lambda])^{2} \pi(\lambda) d\lambda$$
$$= E[\lambda^{2}] - (E[\lambda])^{2}$$

– αth percentile:

$$\alpha = P\{\lambda \le \lambda_{\alpha}\} = \int_{0}^{\lambda_{\alpha}} \pi(\lambda) \ d\lambda$$

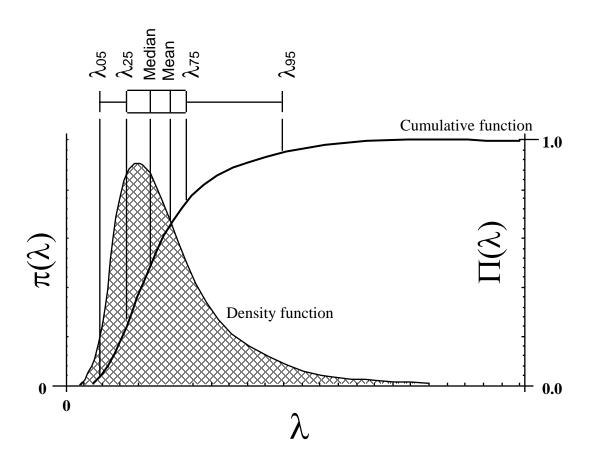
– 95th percentile:

$$0.95 = \int_0^{\lambda_{0.95}} \pi(\lambda) \, d\lambda$$



Uncertainties

Probability of Parameter Value





Error Factors (EF)

- Lognormal distribution
- $f(x) = \frac{1}{x\sqrt{2\pi\sigma^2}}e^{-(\ln(x)-\mu)^2/2\sigma^2}$
- for x > 0
- SAPHIRE software (software used for SPAR models development)
 - requires the EF and mean
 - where: $\mu_{ln} = e^{\mu + \frac{\sigma^2}{2}}$ and $EF = e^{1.645\sigma}$
- PRAs use lognormal distributions and 90% coverage for components.
- Depending upon information error factors can be calculated as:

$$-EF = \sqrt{\lambda_{95}/\lambda_{05}}$$

- $-EF = median/\lambda_{05}$
- $-EF = \lambda_{95}/median$



Other Distributions (commonly used for data analysis)

- Beta distribution
- $f(x) = \left[\frac{1}{B(a,b)}\right] x^{a-1} (1-x)^{b-1}$
- for $0 \le x \le 1$, where B(a,b) is the beta function
- SAPHIRE software (software used for SPAR models development)
 - requires the b parameter and mean
 - a is calculated: $a = (\mu^*b)/(1-\mu)$
 - where: $\mu = a/(a+b)$
- PRA typically assume beta distribution for demand related components (e.g., fails to start)

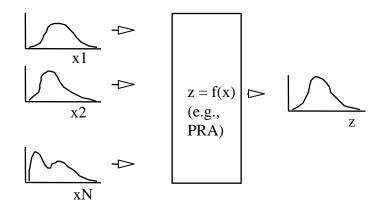


Other Distributions (commonly used for data analysis)

- Gamma distribution
- $f(x) = \left[\frac{\lambda^r}{\Gamma(r)}\right] x^{r-1} e^{-\lambda x}$
- for x > 0, where $\Gamma(r)$ is the gamma function
- SAPHIRE software (software used for SPAR models development)
 - requires the r parameter and mean
 - $-\lambda$ is calculated: $\lambda = r/\mu$
 - where: $\mu = r/\lambda$
- PRAs typically assume gamma distribution for operating related components (e.g., fails to run)

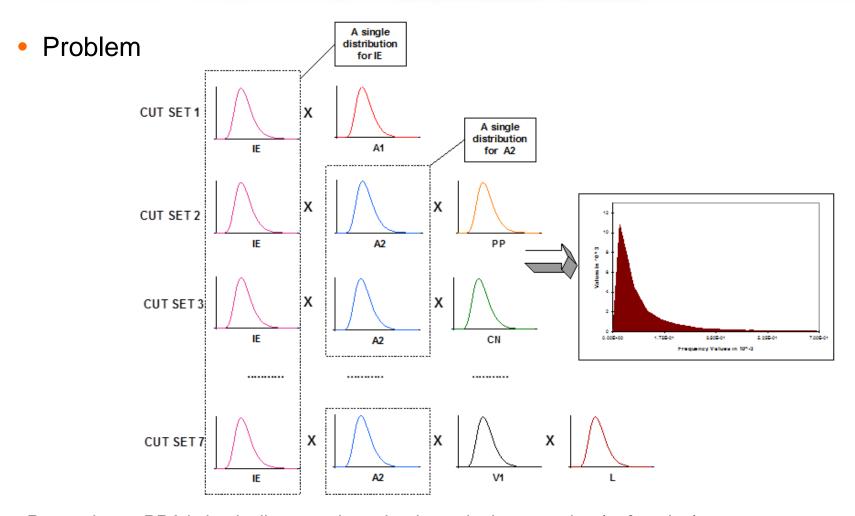


Problem



Remember, a PRA is basically a very large boolean algebra equation (or function)





Remember, a PRA is basically a very large boolean algebra equation (or function)



- Method of Moments
 - Let X and Y be independent variables, and let
 Z = X + Y
 - The mean and variance of Z can then be found:

```
E[Z] = E[X] + E[Y]

Var[Z] = Var[X] + Var[Y] (if X and Y independent)
```



Method of Moments
 More generally, if X and Y are dependent,
 Var[Z] = Var[X+Y]

- $= E[(X+Y-E[X+Y])^2]$
- $= E[(X+Y)^2] E[X+Y]^2$
- $= E[X^2] + 2E[XY] + E[Y^2] E[X]^2 2E[X]E[Y] E[Y]^2$
- = Var[X] + Var[Y] + 2Cov[X,Y]



- Method of Moments
 - Let X and Y be independent variables, and let
 Z = X•Y
 - Then

```
E[Z] = E[X] \cdot E[Y]

Var[Z] = Var[X] \cdot Var[Y] + Var[X] \cdot E[Y]^2 + Var[Y] \cdot E[X]^2
```

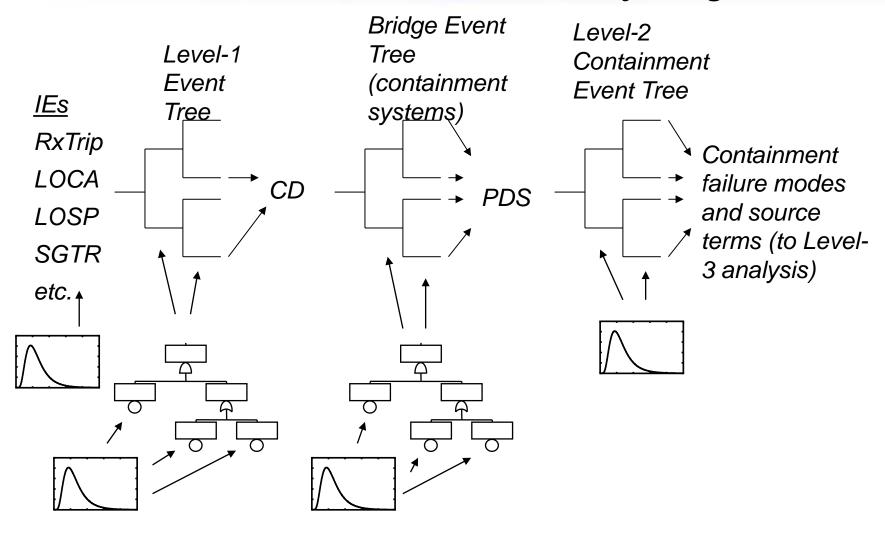


Analytical Methods Impractical

- Typical PRA comprises
 - Hundreds (if not thousands) of basic events
 - Many tens of significant core damage sequences
 - Often hundreds of thousands (if not millions) of core damage sequence cut sets
- Analytical methods not just difficult, but infeasible



The Problem: Level-1/2 PRA Uncertainty Integration



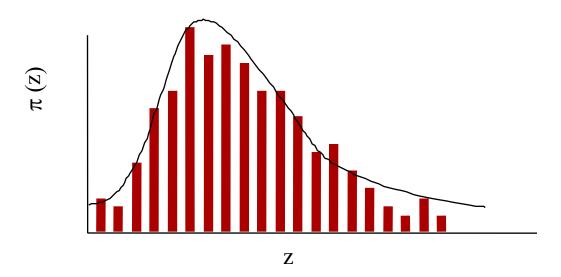


- Simulation methods are only practical approach
 - Simply sample from possible input values many times and plot results
- Two simulation methods commonly used
 - Monte Carlo
 - Latin Hypercube



Propagation of Uncertainties

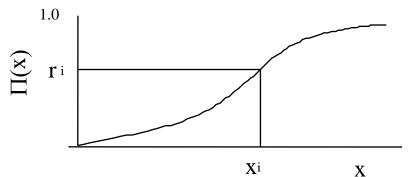
- Monte Carlo
 - Empirically generates distribution for Z = f(X, Y) by sampling from distributions for X and Y





Propagation of Uncertainties

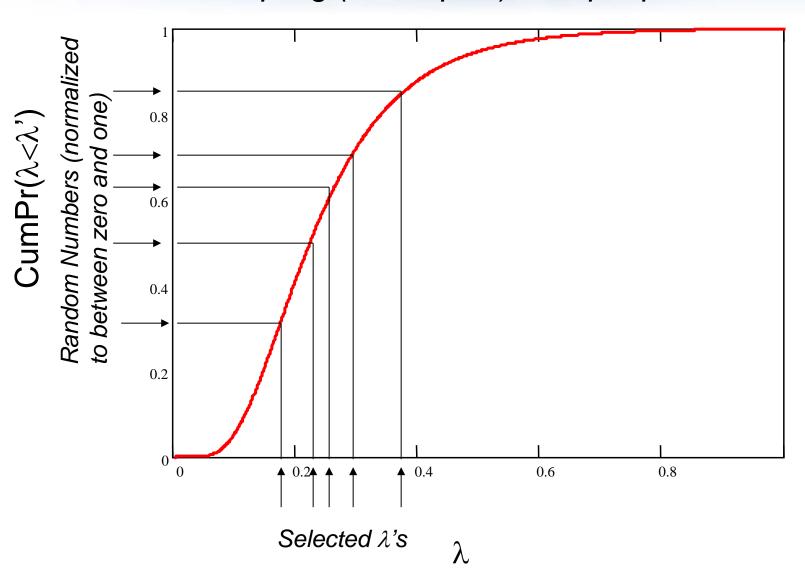
- Monte Carlo
 - Sampling approach (one variable)



- Cautions
 - Sampling extreme values
 - Accuracy (proportional to $1/\sqrt{N}$ (N=# samples)
 - Sampling algorithm and random # generator



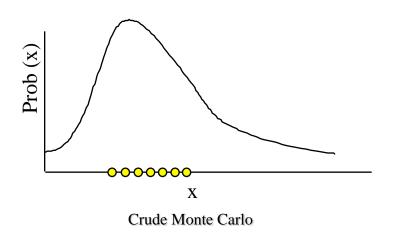
Monte Carlo Sampling (5 Samples) on input parameter λ

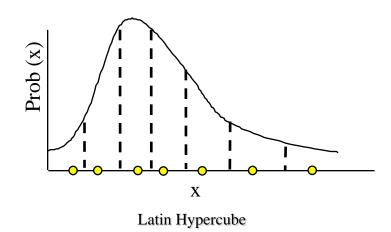




Propagation of Uncertainties

- Latin Hypercube
 - Empirically generates distribution for Z = f(X) by stratified sampling from distribution for X

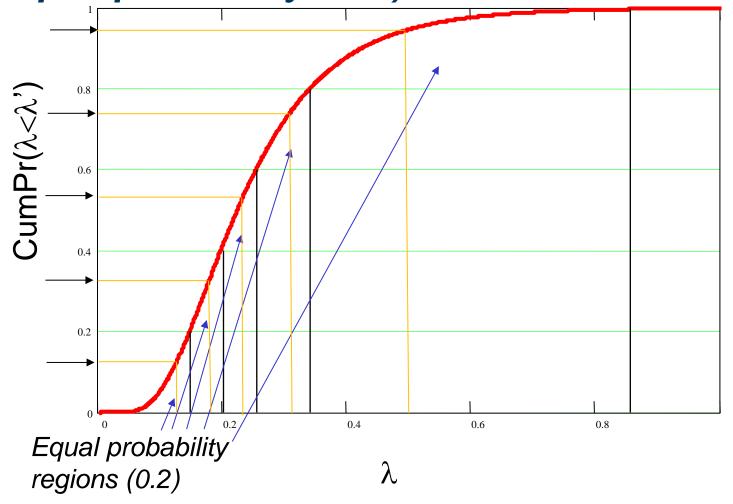




Better coverage of extreme values than Monte Carlo



Latin Hypercube Sampling (one λ selected from each equal-probability area)



System Modeling Techniques for PRA

Lecture 5 - Event Trees





Objectives

- Understand underlying process implied by event tree models
- Understand common event tree conventions
- Understand model applications and limitations
- Outline
 - Appropriate applications for event trees
 - Event tree conventions and construction
 - Modeling of dependencies



Event Trees

- Model what happens after initiating event
 - Typically (but not necessarily), a chronological ordering of major events
- Reflect system interactions
- Provide vehicle for sequence quantification
 - A sequence is an initiating event combined with a set of top events, usually system successes and failures
- Provide simple display of results

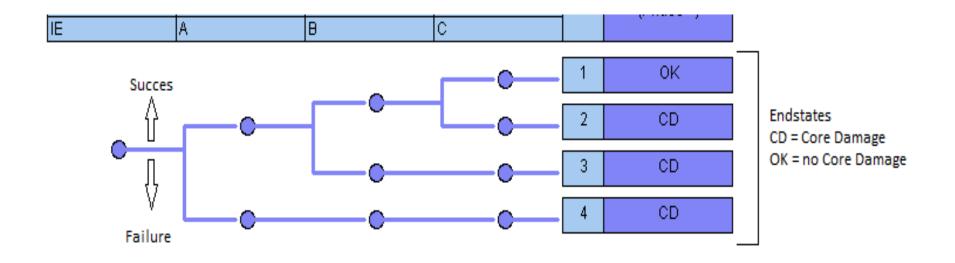


Event Tree Underlying Model

- After initiating event, safety barriers are challenged
- Barrier (system) failure is an aleatory event
 - IE * barrier success/failure → assumed to be Poisson distributed
- Overall sequence frequency is λ φ
 (frequency of IE) x (Probability of system failure)
- λ and φ have uncertainty (epistemic)



Event Tree Models Sequence of Events



That is, IE occurs, then a combination of plant systems A, B and C are challenged.



Two Basic Approaches for Event Tree Models

- Analysis process includes two methods
- Linked fault trees (event trees are the mechanism for linking the fault trees)
 - Employs Boolean logic and fault tree models to pick up intersystem dependencies
 - Sometimes called Small-ET/Large-FT approach, used by most of the PRA community
- Event trees with boundary conditions (BC) (many event trees constructed, each with a unique set of support system BC)
 - Involves analyst quantification and identification of intersystem dependencies
 - Sometimes called Large-ET/Small-FT or PL&G approach



Event Tree Construction

- Modeling Approach
 - Linked fault trees
 - Automatic treatment of shared event dependencies
 - One-step quantification
 - Often use large, general-purpose fault trees
 - Used by SPAR models and majority of utility PRAs



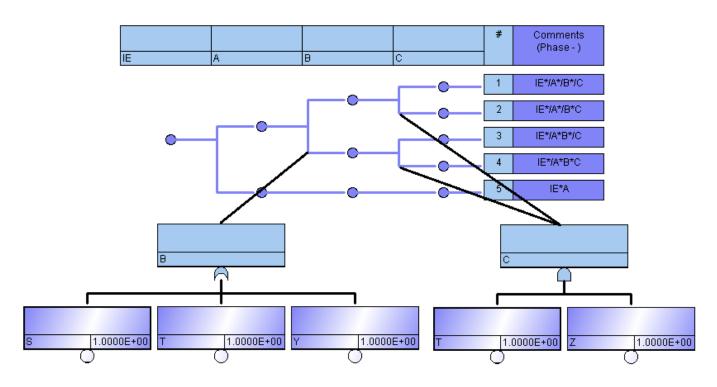
Event Tree with Boundary Conditions

- Modeling Approach
 - Objective: Explicitly separate-out dependencies to facilitate quantification of sequences
 - Focuses attention on context (i.e., the boundary conditions) for performance
 - Requires intermediate numerical results (conditional split fractions)
 - Often implemented using multiple, linked event trees
 - Sometimes referred to as Large-ET approach



Both Event Tree Approaches Link Models*

Fault trees to event trees:

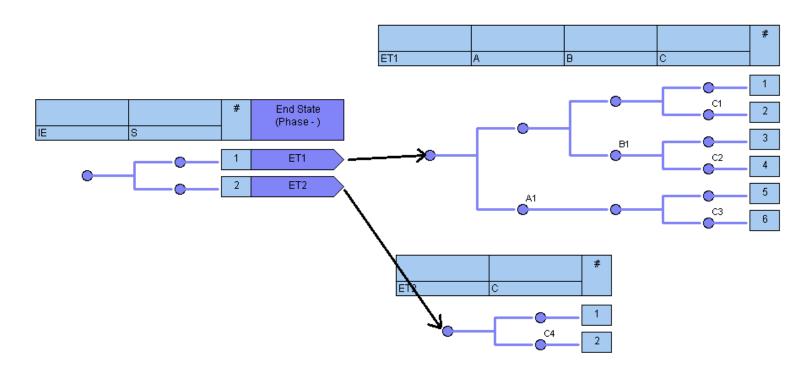


^{*} Necessary in order to accurately reflect dependencies



Both Event Tree Approaches Link Models*

Event trees to event trees:



^{*} Necessary in order to accurately reflect dependencies



Dependent Failures Overview

- Importance of Modeling
 - For systems with defense in depth, an accident requires failure of multiple safety barriers
 - Multiple independent failures are highly unlikely (unless safety barriers are unreliable)
 - Scenarios involving coupled failures of barriers will dominate risk
 - If A and B are dependent, then
 - P(AB) ≠ P(A) * P(B), and instead...
 - P(AB) = P(A) * P(B|A) = P(B) * P(A|B)



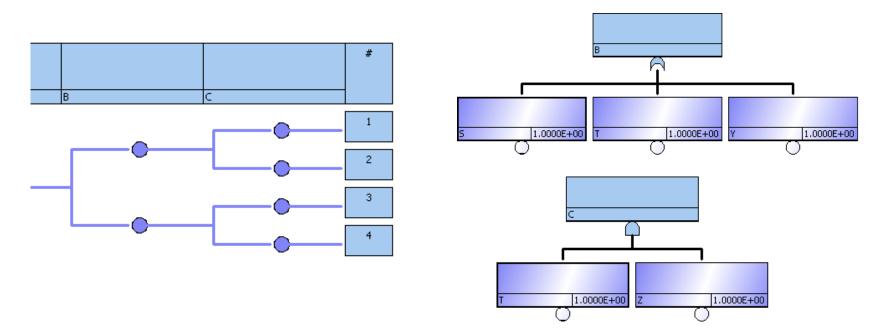
Modeling Dependent Failures

- Analysis Approaches
 - Explicit modeling
 - Implicit modeling
 - Parametric common cause failure analysis, discussed later



Dependencies Modeled in Fault Trees

Example of shared equipment dependency:



Sequence 4 = B * C (i.e., both B and C occur/fail)

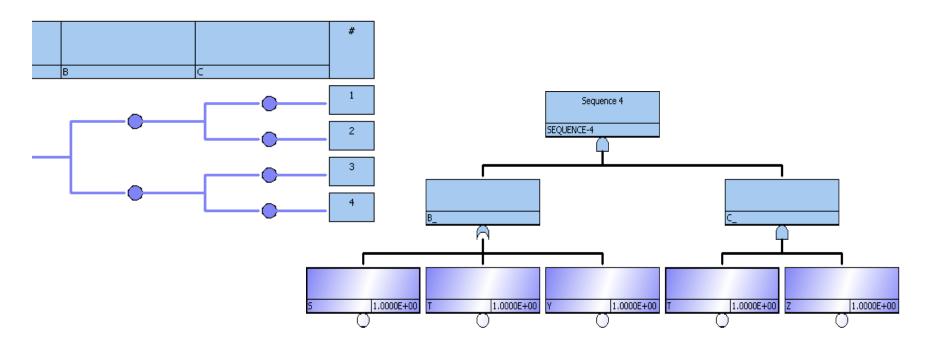


Shared Equipment Dependencies

Fault Tree Linking for Sequence 4 (B and C)

- Sequence
$$4 = (S + T + Y)*(T*Z)$$

= $(S*T*Z + T*T*Z + Y*T*Z)$
= $T*Z$





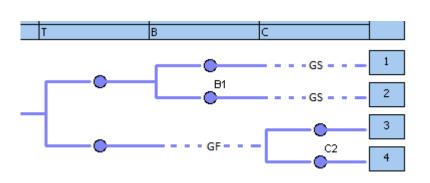
Practice Example

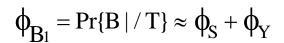
 Re-Solve Sequence 4 with System-B as an AND gate, and System-C as an OR gate.



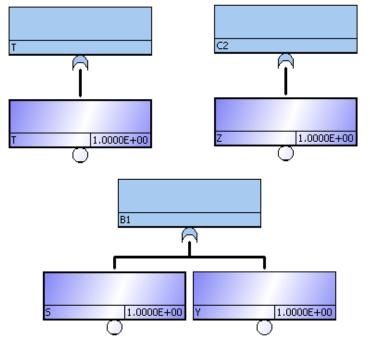
Dependencies Modeled in Event Trees

- Event Trees with Boundary Conditions
 - Dependency can be represented with a separate top event (usually used for support systems)





$$\phi_{C_2} = \Pr\{C \mid T, B\} = \phi_Z$$



GS - Guaranteed Success

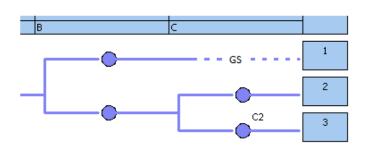
GF - Guaranteed Failure



Shared Equipment Dependencies Without Separating as a Support System

- Event Trees with Boundary Conditions
 - Shared equipment dependencies can also be modeled using just conditional split fractions
 - Example:

Sequence
$$3 = B*C = (S + T + Y)*(T*Z) = T*Z$$

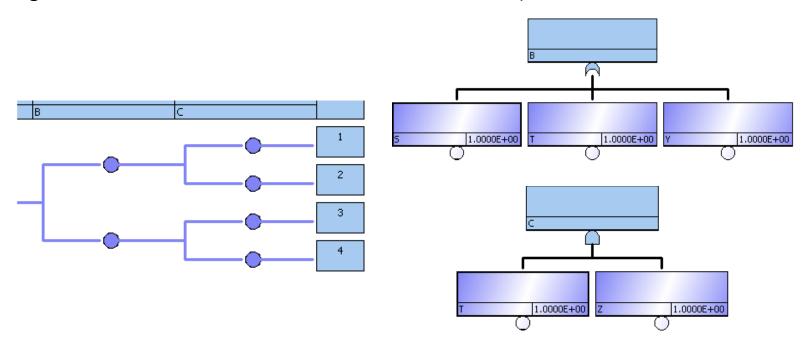


$$\begin{split} \varphi_{C_2} &= \text{Pr}\{C \mid B\} = \frac{\text{Pr}\{B \text{ AND } C\}}{\text{Pr}\{B\}} = \frac{\text{Pr}\{T * Z\}}{\text{Pr}\{S + T + Y\}} \\ &\approx \frac{\varphi_T \cdot \varphi_Z}{\varphi_S + \varphi_T + \varphi_Y} \end{split}$$



Practice Example

- Shared equipment dependency in linked fault trees
- Solve for Sequence 2 (via fault tree linking, need to use Boolean Algebra rules from Lecture-3 on Fault Trees)



System Modeling Techniques for PRA

Lecture 6 - Sequence Models





Objectives

- Understand general process of modeling "systems"
- Greater understanding of event tree modeling techniques
- Outline
 - PRA Modeling Process
 - Initiating Events
 - Event Tree Modeling Techniques
 - Functional Event Trees
 - Systemic Event Trees
 - Sequence Logic and Cut Sets



PRA Modeling Process

- Identify initiating events
- Identify mitigating functions
- Develop event trees for sequence logic
- Develop success criteria for top events
- Develop fault trees for top events
- Develop detailed sequence logic
 - Sequence cut sets (linked fault tree approach)
 - Conditional split fractions (Event Trees w/BC)



Initiating Events

- Methods for Identification
 - Deductive methods
 - Master logic diagram (what causes a reactor trip?)
 - Failure modes and effects analysis (FMEA)
 - Analysis of historical events
 - Licensee event reports
 - Comparison with other studies
 - Feedback from modeling
 - Support system dependencies identified



Initiating Events

- Potential Problem Areas
 - Quantification given little or no statistical evidence
 - Large LOCA frequency (none have occurred)
 - Violations of Poisson assumptions
 - Time dependent failure rate (aging)
 - Too many initiating events
 - Lack of completeness
 - Ambiguity in definition
 - Does loss of feedwater imply the condensate system is unavailable?



Development of Event Trees

- Unique event tree developed for each initiating event
 - Can group like initiators if they have similar impacts to the plant
- Based on safety functions necessary to achieve safe shutdown (functional event tree)
- Top events list systems capable of performing necessary safety functions (success criteria)



Functional Event Tree

High-level representation of vital safety functions required to mitigate abnormal event

- Generic response of the plant to achieve safe and stable condition
- What safety functions must be fulfilled?
 - For example:

Reactor subcritical

Early core cooling (injection)

Late core cooling (recirculation)

 Provides a starting point for more detailed system-level event tree model



Functional Event Tree

	Initiating Event	Reactor Trip	Short term Core Cooling	Long term Core Cooling	#	End State (Phase -)
ΙE		RX-TR	ST-CC	LT-CC		
			_		1	OK
					2	LATE-CD
	0	1		—	3	EARLY-CD
			 0		4	ATWS



Identify Systems Capable of Fulfilling Functions

- For each initiating event identified
 - Which systems are capable of providing:
 - Reactor subcritical
 - Early core cooling (injection)
 - Late core cooling (recirculation)
- Specific success criteria need to be defined for each system



Success Criteria

/E	Reactor Trip	Short Term Core Cooling	Long Term Core Cooling
Trans	Auto Rx Trip or Man. Rx Trip	PCS or 1 of 3 AFW or 1 of 2 PORVs & 1 of 2 ECI	PCS or 1 of 3 AFW or 1 of 2 PORVs & 1 of 2 ECR
LOCA	Auto Rx Trip or Man. Rx Trip	1 of 2 ECI	1 of 2 ECR

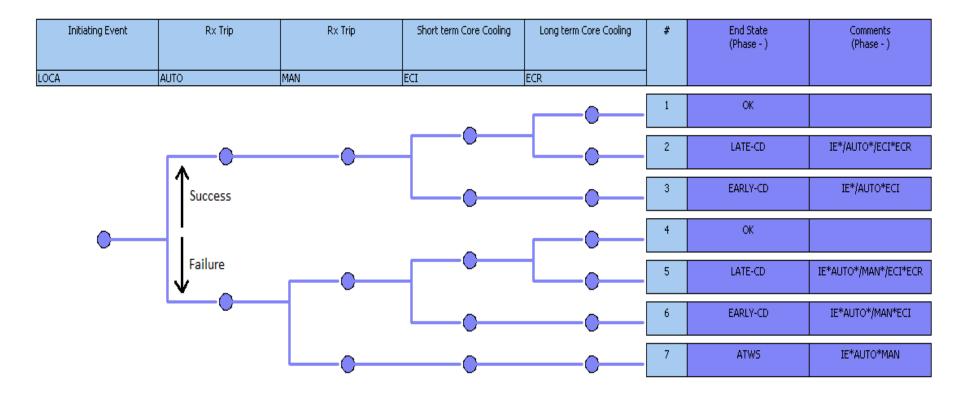


System-Level Event Tree

- Typical ET seen in PRAs
- ET re-drawn after inserting systems as ET top-events
- More top-events consequently more complicated logic
- Unique event tree developed for each initiating event
 - Implies unique plant response to each IE
 - If plant response is not unique, simply combine IE frequencies into a single IE



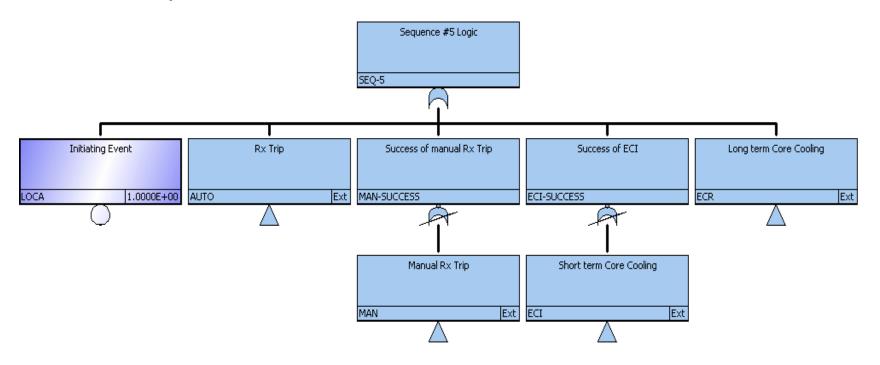
Accident Sequences From ET





Sequence Logic Used to Combine System Fault Trees into Accident Sequence Models

- System fault trees (or cut sets) are combined, using Boolean algebra, to generate core damage accident sequence models.
 - CD seq. #5 = LOCA * AUTO * /MAN * /ECI * ECR





Sequence Cut Sets Generated From Sequence Logic

- Sequence cut sets generated by combining system fault trees (or cut sets) comprised by sequence logic
- Cut sets can be generated from sequence #5 "Fault Tree"
 - Sequence #5 cut sets = (LOCA) * (AUTO cut sets) * (/MAN cut sets) * (/ECI cut sets) * (ECR cut sets)
 - Or, to simplify (avoid complemented terms) the calculation (via "delete term")
 - Sequence #5 cut sets ≈ (LOCA) * (AUTO cut sets) * (ECR cut sets) minus any cut sets that contain (MAN + ECI cut sets)
 - Develop cut set list for: LOCA * AUTO * ECR
 - Develop cut set list for: MAN + ECI
 - Look for item 2 cut sets in item 1 cut sets, and delete them since logically they cannot occur



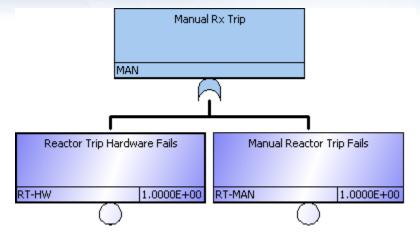
Delete Term Example

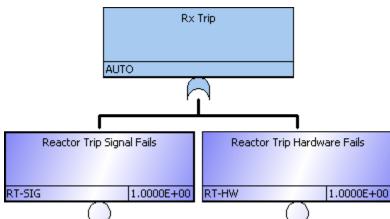
- Sequence logic = IE * /Inj * Rec
 Inj = P + V1 => /Inj = /P * /V1
 Rec = P + V2
- Cut sets = IE * (/P * /V1) * (P + V2)
 = IE * /P * /V1 * P +
 IE * /P * /V1 * V2.
 = IE * /P * /V1 * V2.
- Cut sets via delete term:
 - Seq. CS = IE * (P + V2) minus cut sets that contain Inj (failure) cut sets.
 - = IE * P + IE * V2 (minus cut sets that contain either P + V1).
 - = IE * V2.



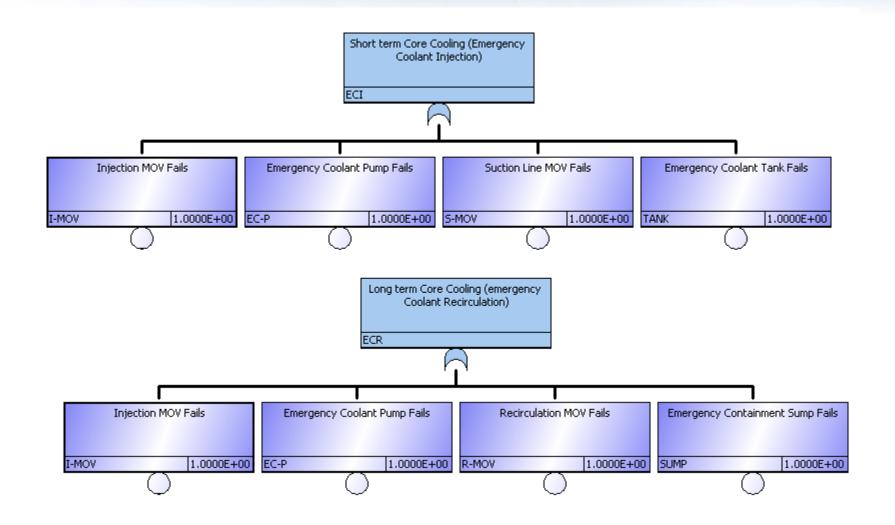
Practice Example:

Generate Cut Sets for Sequence #5









System Modeling Techniques for PRA

Lecture 7 - Common Cause Failure Models





Objectives

- Understand fundamental theory of CCF modeling
- Become familiar with different CCF models
- Outline
 - Motivation for CCF Models
 - Basic Parameter Model
 - Motivation for Parametric Models
 - Beta-Factor Model
 - Multiple Greek Letter Model
 - Alpha-Factor Model
 - Notes on Analysis Process



Why is CCF Modeling Important?

- Commercial nuclear power plants are designed with safety a priority
 - Redundancy
 - Diversity
 - Defense in depth
- NPP are effectively single failure "proof"
- Only combinations of failures can seriously challenge reactor integrity



Focus on Dependent Failures

- Combinations of independent failures extremely rare events
- Dependent failures pose major challenge to safety
 - Shared equipment and support system dependencies
 - Explicitly modeled in PRA logic
 - Failures of multiple components from a common (or shared) cause
 - Cause not explicitly modeled
 - Treated parametrically CCF models



Definition of Dependency

Events A and B are said to be dependent events if

$$P(A*B) = P(A|B) * P(B)$$

= $P(B|A) * P(A)$
\(\neq P(A) * P(B)

- Typically (not always) if events are dependent
 P(A*B) > P(A) * P(B)
 - This is why they are a safety concern



Examples of CCF

- Human interaction
 - Maintenance technician incorrectly sets setpoints on multiple components
 - Incorrect or incorrectly applied lubricant
- Physical or environmental
 - Bio-fouling (e.g., clams, muscles, fish)
 - Design or manufacturing defect
 - Contamination in lubricant or fuel
- Again, not represented explicitly, only parametrically



Basic Parameter Model

- Background
 - Consider a group of 3 identical components: A, B, and C.
 - Notation:
 - \overrightarrow{ABC} = Failure of A, success of B and C
 - $AB\overline{C}$ = Failure of A and B, success of C
 - $ABC \equiv Failure of A, B and C$
 - $Q_{XYZ} \equiv Probability of event XYZ$
 - Modeling assumption: Failure probabilities are symmetrical

$$Q_{ABC} = Q_{ABC}^{-} = Q_{ABC}^{-} \equiv Q1$$
 (only one component fails)

$$Q_{ABC} = Q_{ABC} = Q_{ABC} = Q_{ABC} = Q_{ABC} = Q_{ABC}$$
 (only two components fail)

$$Q_{ABC} \equiv Q3$$

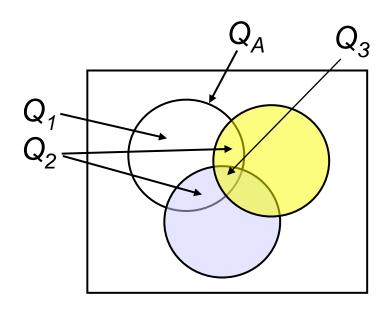
X Means component X Is not failed



Basic Parameter Model

- Model Parameters
 - The Q_{k's} are system parameters
 - They quantify probabilities of system events (CCFs for specific groups of k components)
 - Relating Q_{k's} to the total component failure rate:

$$\begin{aligned} Q_{t(A)} &= Q_A = Q_{A\overline{BC}} + Q_{A\overline{BC}} + Q_{AB\overline{C}} + Q_{AB\overline{C}} + Q_{ABC} \\ &= Q_1 + 2Q_2 + Q_3 \end{aligned}$$





Basic Parameter Model

- Model Parameters
 - General expression: $Q_t = \sum_{k=1}^m \binom{m-1}{k-1} Q_k$ where:
 - m = number of identical components (size of "common cause component group")
 - Q_t = total failure probability for a given component

Binomial Coefficient:

$$\binom{m-1}{k-1} \equiv \frac{(m-1)!}{(k-1)!(m-k)!}, (x! \equiv x * (x-1) * (x-2) * \dots * 2 * 1)$$



Basic Parameter Model - example

• Find Q_t when m = 3

$$Q_{t} = \sum_{k=1}^{m} {m-1 \choose k-1} Q_{k} \qquad Q_{t} = \sum_{k=1}^{3} {3-1 \choose k-1} Q_{k}$$



Motivation for Parametric Models

- Data needed to estimate Q_k in basic parameter model are not generally available
- Available data include:
 - Generic failure probabilities/rates for components (i.e., Q_t)
 - Compilations of dependent failures (without demand data)
- Alternative models use latter information to develop relative fractions of dependent failure events



- Originally developed for 2-component systems; later extended to handle larger systems
- Based on notion that component failures can be divided into two groups
 - Those that are independent
 - Those that involve dependent failure of all components



Allocation model:

$$Q_t = Q_1 + Q_m = (1 - \beta)Q_t + \beta Q_t$$

Independent dependent contribution

Therefore:

$$\beta \equiv Q_m/(Q_1+Q_m)$$



β -Factor Estimation

In general,

$$Q_k = \begin{cases} (1-\beta)Q_t & k=1\\ 0 & 2 \leq k < m\\ \beta Q_t & k=m \end{cases} \qquad \hat{\beta} = \frac{\sum\limits_{k=2}^{m}kN_k}{\sum\limits_{k=1}^{m}kN_k}$$

where:

 N_k is the number of <u>events</u> involving failure of exactly k components so that the product kN_k represents number of failed <u>components</u>.



β -Factor Estimation

- Example:
 - Consider a system with two components: A and B.
 - Component A has failed 3 times in 50,000 hours of service; out of those 3 failure events, 1 event was a common cause failure (involving component B).
 - Component B also has 50,000 hours of service, and it has failed 2 times (including the joint failure event with A).



β-Factor Estimation

Point estimates for λ_t and β are then,

$$\lambda_t = 5 \text{ failures } / 100,000 \text{ hr} = 5.0 \text{ x } 10^{-5}/\text{hr}$$
 $\beta = 2/(3+2) = 0.4$

And,

$$\lambda_{CCF} = \lambda_t * \beta = 5.0 \times 10^{-5}/hr * 0.4$$

 $\lambda_{CCF} = 2.0 \times 10^{-5}/hr$

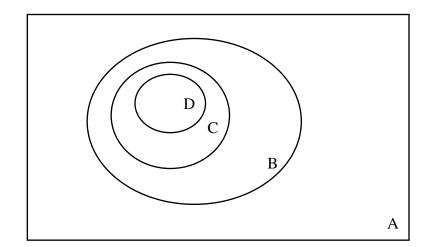
• In the absence of plant-specific data, base component failure rate (λ_t) is obtained from generic failure rates



- β factor extended to treat multiple levels of CCF
- Definitions:
 - $-\beta$ = conditional probability that cause of a specific component failure will be shared by one or more additional components
 - $-\gamma$ = conditional probability that common cause failure of a specific component that has failed two components will be shared by one or more additional components
 - $-\delta$ = conditional probability that common cause failure of a specific component that has failed three components will be shared by one or more additional components



- Parameters
 - A: Failures involving component X
 - B: Failures involving CCF of X and at least 1 other component
 - C: Failures involving CCF of X and at least 2 other components
 - D: Failures involving CCF of X and at least 3 other components



$$\beta = P(B|A)$$

$$\gamma = P(C|B)$$

$$\delta = P(D|C)$$



Estimators

$$\hat{\beta} = \frac{\sum\limits_{k=2}^{m} kN_k}{\sum\limits_{m=1}^{m} kN_k}, \quad \hat{\gamma} = \frac{\sum\limits_{k=3}^{m} kN_k}{\sum\limits_{k=4}^{m} kN_k}, \quad \hat{\delta} = \frac{\sum\limits_{k=4}^{m} kN_k}{\sum\limits_{k=1}^{m} kN_k}$$

 N_k is the number of <u>events</u> involving the failure of exactly k components. Therefore, kN_k is the number of failed <u>components</u>.



Relations to Q_k's

$$- m = 3$$

$$- m = 4$$

$$\hat{\beta} = \frac{2N_2 + 3N_3}{N_1 + 2N_2 + 3N_3}$$

$$\hat{\beta} = \frac{3N_3}{N_3}$$

$$\hat{\gamma} = \frac{3N3}{2N2 + 3N3}$$

$$\hat{\beta} = \frac{2N_2 + 3N_3 + 4N_4}{N_1 + 2N_2 + 3N_3 + 4N_4}$$

$$\hat{\gamma} = \frac{3N_3 + 4N_4}{2N_2 + 3N_3 + 4N_4}$$

$$\hat{\delta} = \frac{4N4}{3N3 + 4N4}$$

$$Q_1 = (1 - \beta)Q_t$$

$$Q_2 = \frac{1}{2}\beta(1-\gamma)Q_t$$

$$Q_3 = \beta \gamma Q_t$$

$$Q_1 = (1 - \beta)Q_t$$

$$Q_2 = \frac{1}{3}\beta(1-\gamma)Q_t$$

$$Q_3 = \frac{1}{3}\beta\gamma(1-\delta)Q_t$$

$$Q_4 = \beta \gamma \delta Q_t$$



- Background
 - Simple expressions for exact distributions of MGL parameters (accounting for uncertainties) are not always obtainable
 - Approximate methods leading to point estimators provided earlier underestimate uncertainty
 - α -factor model developed to address this issue



- Definition
 - α_k = conditional probability that a failure event involves k components failing due to a shared cause, given a failure event

$$\alpha_{k} = \frac{\binom{m}{k}Q_{k}}{\sum_{k=1}^{m}\binom{m}{k}Q_{k}} \quad \text{where} \quad \binom{m}{k} = \frac{m!}{k!}(m-k)!$$

Note: This definition emphasizes shocks to the <u>system</u> (i.e., failure events) rather than to the <u>components</u> (i.e., failures)



- Example (m = 3)
 - Failure events involving only 1 component are:

$$\overline{ABC}$$
, \overline{ABC} , \overline{ABC}

Since

$$Q_1 = Q_{\overline{ABC}} = Q_{\overline{ABC}} = Q_{\overline{ABC}}$$
, then $\alpha_1 = \frac{3Q_1}{3Q_1 + 3Q_2 + Q_3}$

Similarly,

$$\alpha_2 = \frac{3Q_2}{3Q_1 + 3Q_2 + Q_3}$$

$$\alpha_3 = \frac{Q_3}{3Q_1 + 3Q_2 + Q_3}$$

– Note that $\alpha_1 + \alpha_2 + \alpha_3 = 1$ as expected.



- Key Expressions
 - Point Estimators

$$\hat{\alpha}_{k} = \frac{N_{k}}{\sum_{i=1}^{m} N_{i}}$$

Expression for Q_k's

$$Q_{k} = \frac{k}{\binom{m-1}{k-1}} \frac{\alpha_{k}}{\sum_{i=1}^{m} \alpha_{i}} Q_{t}$$

(from NUREG/CR-5485, page 41, for non-staggered testing)



- Example (m = 3)
 - Expression for Q_k's

$$Q_1 = \frac{\alpha_1}{\alpha_1 + 2\alpha_2 + 3\alpha_3} Q_t$$

$$Q_2 = \frac{\alpha_2}{\alpha_1 + 2\alpha_2 + 3\alpha_3} Q_t$$

$$Q_3 = \frac{3\alpha_3}{\alpha_1 + 2\alpha_2 + 3\alpha_3} Q_t$$



Example (m = 3) (cont.)

Relationships with MGL parameters

$$\beta = \frac{2\alpha_2 + 3\alpha_3}{\alpha_1 + 2\alpha_2 + 3\alpha_3}$$

$$\alpha_1 = \frac{3(1 - \beta)}{3 - \frac{3}{2}\beta - \frac{1}{2}\beta\gamma}$$

$$\gamma = \frac{3\alpha_3}{2\alpha_2 + 3\alpha_3}$$

$$\alpha_2 = \frac{\frac{3}{2}(\beta - \beta\gamma)}{3 - \frac{3}{2}\beta - \frac{1}{2}\beta\gamma}$$

$$\alpha_3 = \frac{\beta\gamma}{3 - \frac{3}{2}\beta - \frac{1}{2}\beta\gamma}$$



Analysis Process

- General Steps
 - Starting with system logic model, identify common cause component groups
 - Develop CCF model
 - 3. Gather and analyze data
 - Quantify CCF model parameters
 - 5. Quantify CCF basic events



- "Common Cause Component Groups"
 - Definition: A group of components that has a significant likelihood of experiencing a common cause failure event
 - Consider similarity of:
 - Component type
 - Manufacturer
 - Mode of operation/mode of failure
 - Environment
 - Location
 - Mission
 - Test and Maintenance Procedures



- "Common Cause Component Groups"
 - Diversity (e.g., in operation, missions) is a possible reason for screening out
 - Note: diverse components can have common piece parts (e.g., common pumps, different drivers)

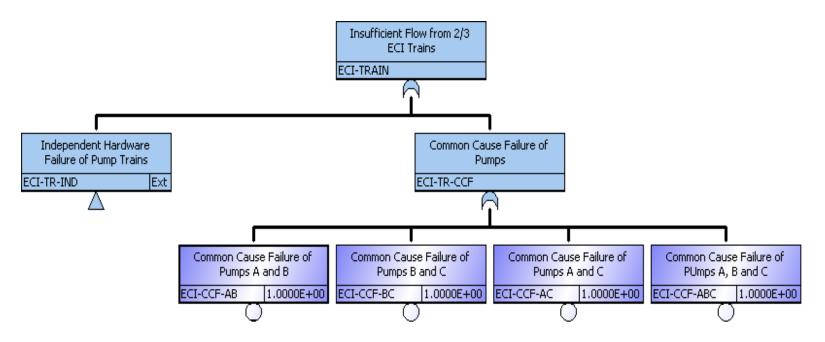


Development of CCF Model

Explicit representation example

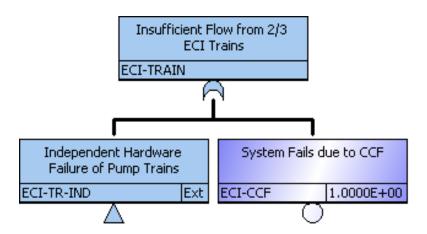
Specific combinations of components

are explicitly shown on fault tree





- Implicit modeling example (3 trains)
 - P(top event due to CCF) = $3Q_2 + Q_3$
 - Probabilities of different combinations are "rolled-up" into the CCF term.





Data Analysis Process

- Data Sources
 - Generic raw data compilations (e.g., LERs, LER summaries, NPE)
 - Plant-specific raw data records (e.g., test and maintenance records, work orders, operator logs)
 - Generic event data and parameter estimates (e.g., NUREG/CR-2770, EPRI NP-3967)
 - NRC/INL CCF database (NUREG/CR-6268)
 - Parameter information stored on the web at: nrcoe.inel.gov/resultsdb/ParamEstSpar/



Data Analysis Process

- Examines failure events (not all demands or success events)
- Relatively few failures are clear-cut CCFs
 - Demands on redundant components do not always occur simultaneously
 - "Failures" are sometimes not demonstrated failures
 - Second component inspected and revealed similar degradation/conditions
- Interpretation and judgment used to "fill-in" the gaps in the data
 - Degradation Value technique
 - Assigns probabilities for likelihood an event was an actual CCF event



Data Analysis Process

Classification example

Plant Type	Event Description	Component Group Size	Degradation Values		
(Date)			P_0	P ₁	P ₂
PWR (12/73)	Two motor-driven AFW pumps were inoperable due to air in common suction line	2	0	0	1

- Data typically collected include
 - Component group size
 - Number of components affected
 - Shock type (lethal vs. non-lethal)
 - Failure mode



Adjusting for System Size

- "Mapping up" and "mapping down" performed for individual p-values
- Algorithms provided in NUREG/CR-4780
- Example: Mapping from m = 3 to m = 2

$$p_0^{(2)} = p_0^{(3)} + \frac{1}{3}p_1^{(3)}$$

$$p_1^{(2)} = \frac{2}{3}p_1^{(3)} + \frac{2}{3}p_2^{(3)}$$

$$p_2^{(2)} = \frac{1}{3}p_2^{(3)} + p_3^{(3)}$$



Adjusting for System Size

- Example: Mapping from m = 3 to m = 4
 - Lethal shock: $p_3^{(3)} = p_4^{(4)}$
 - Non-lethal shock: $p_1^{(4)} = \frac{4}{3}(1-\rho)p_1^{(3)}$ $p_2^{(4)} = \rho p_1^{(3)} + (1-\rho)p_2^{(3)}$ $p_3^{(4)} = \rho p_2^{(3)} + (1-\rho)p_3^{(3)}$ $p_4^{(4)} = \rho p_3^{(3)}$

where $\rho =$ conditional probability of a component's failure, given a non-lethal shock.

System Modeling Techniques for PRA

Lecture 8 – Quantification





Objectives

- Understand the process of quantifying cut sets
- Understand value and limitations of different approximations
- Understand impact of correlation of data on quantification results
- Outline
 - Cut set definition
 - Approximations
 - Correlating failure rates



Cut Sets

- A cut set is a combination of events that cause the "top event" to occur
- Minimal cut set is the smallest combination of events that causes the top event to occur
- Each cut set represents a failure scenario that must be "ORed" together with all other cut sets for the top event when calculating the total probability of the top event



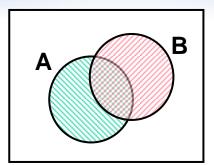
Quantification of Cut Sets

- Three different quantification methods to quantify the probability of cut sets:
 - Exact Solution
 - Rare Event Approximation
 - Minimal Cut Set Upper Bound Approximation
 [also know as Min-Cut Approximation]



Quantification – Exact Solution

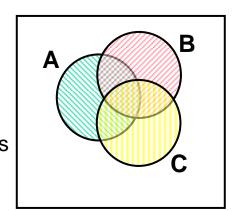
- Exact Solution for Cut Sets = A OR B:
 - -P(Cut Sets) = P(A + B) = P(A) + P(B) P(AB)



Cross terms become unwieldy for large lists of cut sets

For example; if Cut Sets = A OR B OR C, then:

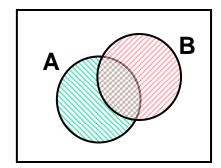
$$P(\text{Cut Sets}) = \\ P(A) + P(B) + P(C) - [P(AB) + P(AC) + P(BC)] + P(ABC) \\ \\ \text{Add the Singles} \qquad \text{Subtract the Doubles} \qquad \text{Add the Triples}$$

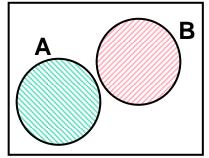




Quantification - Rare Event Approximation

- P(Cut Sets) ≈ sum of probabilities of each individual cut set
- P(Cut Sets) $\approx \sum_{k=1}^{K} P(Cutset_k)$
 - Assumes cross term values are sufficiently small (rare) and thus are ignored (i.e., the cross-term values are simply left out)
 - P(Cut sets) quantified as if the cut sets are mutually exclusive
 - For Example; if Cut Sets = A OR B, thenP(Cut Sets Rare Event) = P(A) + P(B)
- P(A AND B) judged sufficiently small (rare) and are ignored
- In general,
 P(Exact Solution) ≤ P(Rare Event)

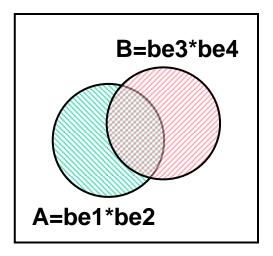






Quantification - Min-Cut Approximation

- $P(Cut Sets) \approx 1 P(Complemented Cut Sets)$
 - P(Minimal Cut Set Upper Bound for Cut Sets) = 1.0 minus the product of each individual cut set NOT occurring
 - P(MCSUB for Cut Sets) = $1 \prod_{k=1}^{K} [1 P(Cutset_k)]$
 - For Example; if Cut Sets = A OR B, then P(Cut Sets Min-Cut) = 1 - [(1 - P(A)) * (1 - P(B))]
- Assumption is that each cut set contains elements that are not shared in any other cut sets (i.e., each cut set is independent of all other cut sets)
- In general,
 P(Exact Solution) ≤ P(Min-Cut) ≤ P(Rare Event)



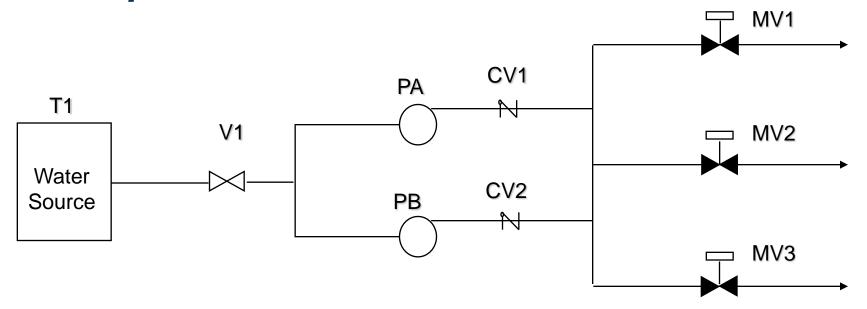


Examples of P(A+B) Quantification Methods for Cut Sets A OR B

Quantification Method	Cut Sets A & B independent; individual cut set values low	Cut Sets A & B independent; individual cut set values high	Cut Sets A & B dependent; mutually exclusive	Cut Sets A & B are not independent (they have shared basic events); individual cut set values low
Cut-Sets = A + B	P(A) = 0.01 P(B) = 0.03	P(A) = 0.4 P(B) = 0.6	B = /A P(A) = 0.4 P(B) = P(/A) = 0.6	Cut Set A = BE1 * BE2 Cut Set B = BE2 * BE3 P(BE1) = 0.1 P(BE2) = 0.1 P(BE3) = 0.3
Exact	= 0.01 + 0.03 - (0.01*0.03) = 0.04 - 0.0003 = 0.0397	= 0.4 + 0.6 - (0.4*0.6) = 1.0 - (0.24) = 0.76	= 0.4 + 0.6 = 1.0	= (BE1*BE2) + (BE2*BE3) - (BE1*BE2)*(BE2*BE3) = (BE1*BE2) + (BE2*BE3) - (BE1*BE2*BE3) = 0.01 + 0.03 - 0.003 = 0.04 - 0.003 = 0.037
Rare Event	= 0.01 + 0.03 = 0.04	= 0.4 + 0.6 = 1.0	= 0.4 + 0.6 = 1.0	= 0.01 + 0.03 = 0.04
MinCut UB	= 1 - [(1-0.01) * (1-0.03)] = 1 - [(0.99) * (0.97)] = 1 - [0.9603] = 0.0397	= 1 - [(1-0.4) * (1-0.6)] = 1 - [(0.6) * (0.4)] = 1 - [0.24] = 0.76	= 1 - [(1-0.4)*(1-0.6)] = 1 - [(0.6)*(0.4)] = 1 - [0.24] = 0.76	= 1 - [(1-0.01) * (1-0.03)] = 1 - [(0.99) * (0.97)] = 1 - [0.9603] = 0.0397



Example Cut Sets - ECI



Success Criteria: Flow from any one pump through any one MV

T_ tank

V_ manual valve, normally open

PS-_ pipe segment

P_ pump

CV_ check valve

MV_ motor-operated valve, normally closed



ECI Component Failure Rates

T1 = 1E-6

V1 = 5E-5

PA = PB = 1E-2

CV1 = CV2 = 1E-4

MV1 = MV2 = MV3 = 3E-3



Cut Sets - Quantify

```
ECI-TOP =

MV1 * MV2 * MV3 +

PA * PB +

PA * CV2 +

CV1 * PB +

CV1 * CV2 +

V1 +

T1
```



Point Estimates

- Point estimate calculation usually refers to mean values.
 - Result will be approximate mean value
 - For Lognormal distribution [mean > median]
 - mean/median = exp{1/2[ln(EF)/z]²}
 (for example: EF = 10, 90% coverage: z = 1.645 and mean/median = 2.66)
 - e.g., for median = 1E-3 and EF = 10
 then
 mean = 1E-3 x 2.66 ≅ 3E-3 (factor of 3 greater than median)



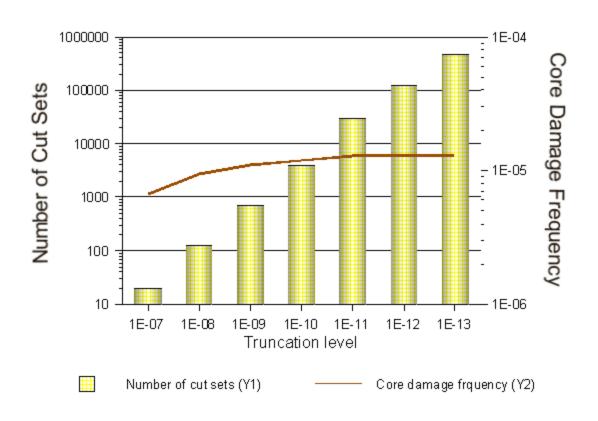
Truncation Issues

- Becoming less of a concern as computer/software increase in capabilities
- Cut set order
 - Truncating on number of basic events in a cut set generally limited to vital area analyses
- Low probability events can accumulate
 - 1,000 cut sets at 1E-9 each = 1E-6
 - 10,000 cut sets at 1E-9 each = 1E-5



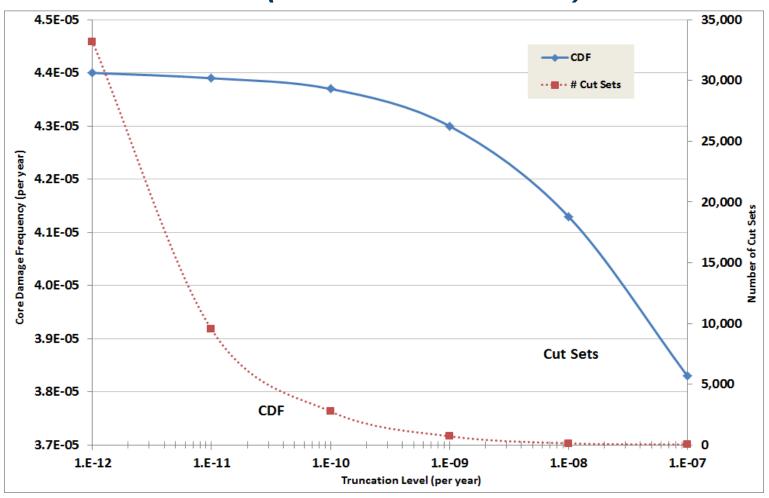
Truncation Issues

Can affect importance analyses...number of basic events in results increases as truncation decreases





CDF and Number of Cut Sets Sensitive to Truncation Limits (PWR SPAR Model)





Correlating Data - Outline

- What are correlated data?
 - Implications on uncertainty results
- Combined (either explicitly or implicitly) data can be interpreted in different ways (depending on our assumed model)
 - Pooling data to estimate an average or mean occurrence rate
 - Models variability among similar individual components/events
 - Models variability among different component/event groups



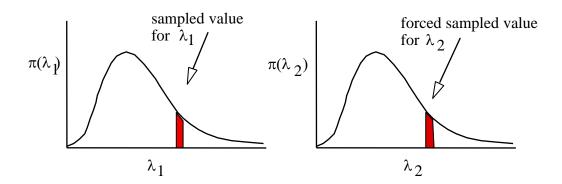
What are Correlated Data?

- Only an issue when performing uncertainty analysis
- When quantifying a model, does the analyst assume
 - All similar (correlated) events occur at the same rate, or
 - Can occurrence rates vary among similar events?
- Specifically, when performing a simulation quantification (Monte Carlo or Latin Hypercube)
 - Should each simulation run pick a single value, which is applied to all similar events, or
 - Pick a different value for each event?



State of Knowledge Dependencies

- Some sources of dependence
 - Common design/manufacturer
 - Organizational factors (including testing and maintenance quality)
- Treatment (e.g., simple two component system)
 - Identical distributions, completely correlated sampling





Effect on Results

- Correlating data produces wider uncertainty in results
 - Without correlating a randomly selected high value will usually be combined with randomly selected lower values (and vice versa), producing an averaging effect
 - Reducing calculated uncertainty in the result
 - Mean value of probability distributions that are skewed right (e.g. lognormal, commonly used in PRA) is increased when uncertainty is increased

Reference: Pitfalls of Risk Calculations, Reliability Engineering 2, 1981, pg. 135 – 145, Apostolakis and Kaplan



Correlating Failure Rates

- Important when uncertainties are included in analysis
- Mathematically...
 - $E(\lambda^2) \neq E(\lambda)^2$
 - $E(\lambda^2) = E(\lambda)^2 + Var(\lambda)$
- Simple example:
 - 2 valves, failure of both fails system
 - If $E(\lambda) = 1E-3$ (mean), EF = 10, and λ is lognormally distributed, then
 - $-E(\lambda)^2 = (10^{-3})^2 = 1E-6$ (uncorrelated)
 - $E(\lambda^2) = (10^{-3})^2 + Var(\lambda) \cong 6E-6$ (correlated)



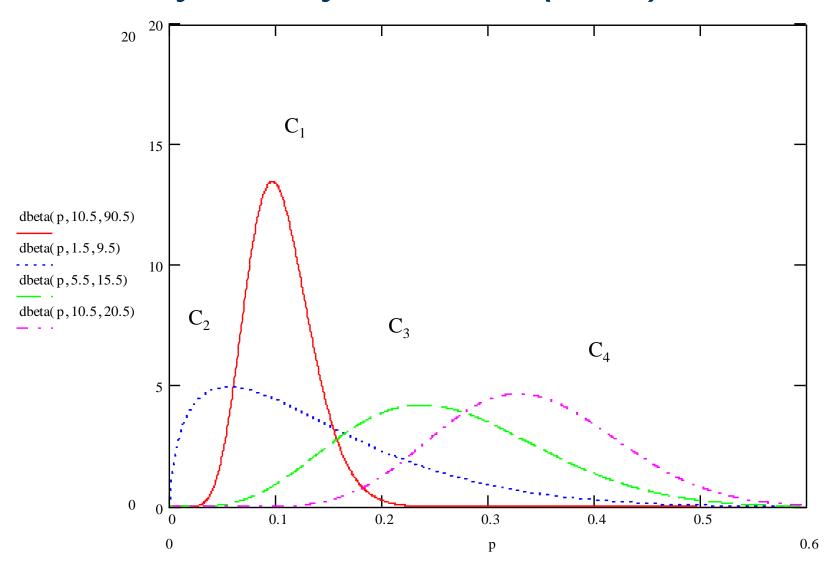
When Should Events Be Correlated?

Issue illustrated with following example with four nominally identical components

Component	C_1	C_2	C_3	C_4
Failures	10	1	5	10
Demands	100	10	20	30



Probability Density Functions (PDFs)





However - Common Situation is to "pool" data for like components

Component	C_1	C_2	C ₃	C ₄	Aggregate
Total Failures					26
Total Demands					160
Average Failure					0.16
Probability					

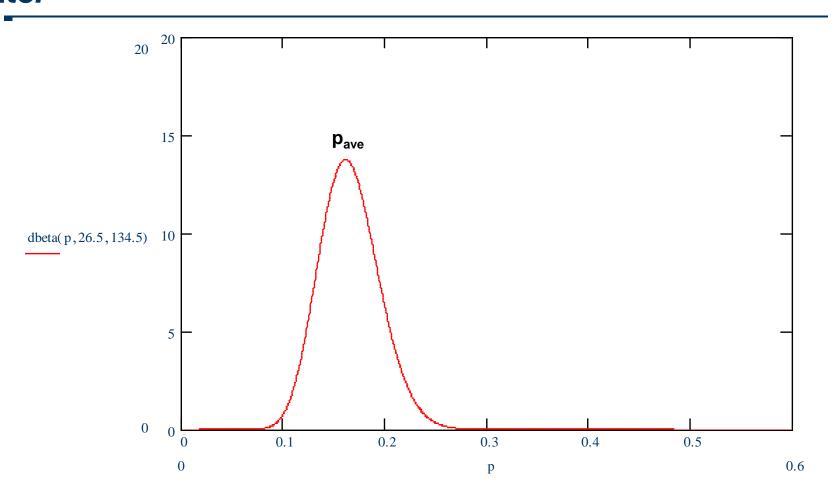


Pooled Data Only Provides an Estimate of the Average Probability

- $f_t / d_t = p_{ave}$
- Effectively, a weighted average of the failure probabilities for C₁, C₂, C₃ and C₄
- Uncertainty associated with p_{ave} represents our knowledge in estimate of p_{ave} (not variability in p_i's)
- More data reduces uncertainty in pave



Pooling Data Gives Reduced Uncertainty. But, Uncertainty Only Reflects Confidence in Our Estimate of Average Failure Rate.



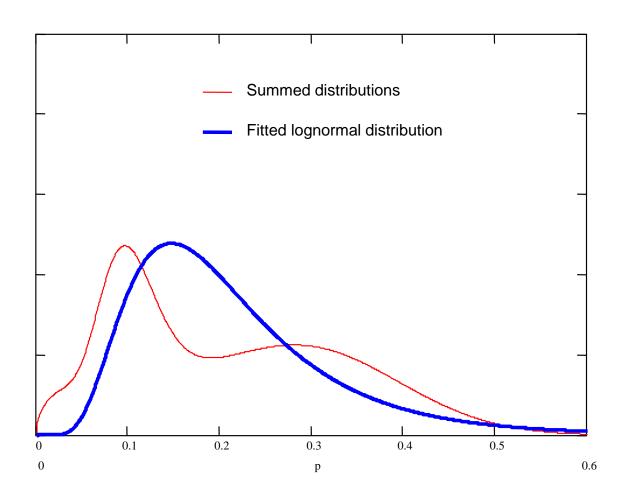


Pooled Data Implies Correlated Failure Rates

- Used to estimate a single parameter: p_{ave}
- Implies $p_1 = p_2 = p_3 = p_4 = p_{ave}$
- Assumed model based on existence of a single "true" value for p that describes performance of all similar components (i.e., the C_i's)
- Uncertainty a measure of knowledge in p_{ave} estimate
 - Therefore, failure rate estimates are correlated



Summing Distributions (Not Data) Captures Variability Among Possible Values of p





Should Not Correlate Samples From PDF That Models Variability

- Basic Premise: p₁ ≠ p₂ ≠ p₃ ≠ p₄ ≠ p_{ave}
- Uncertainty in distribution reflects variability in components operating conditions and environment
- Conditions at one component are NOT related to conditions at another component
- Failure rates are NOT correlated



Conclusion

- If PDF on input data reflects knowledge on an average value using pooled data, then should correlate
- If PDF on input data reflects variability or range of possible values, then should not correlate
- If PDF on input data reflects variability or range of groups of values (e.g., plant-to-plant variability), then should correlate (i.e., once a plant is selected the data should be consistent)
- Correlating failure events will generally produce higher system failure probabilities (and higher core damage frequencies)

System Modeling Techniques for PRA

Lecture 9 - Data Analysis





Objectives

- Understand the data requirements of a PRA, including:
 - Implications of modeling assumptions
 - Including Bayesian techniques
 - Potential pitfalls
- Outline
 - PRA Parameters
 - Bayesian Methods
 - Component Failure Rates
 - Component Failure Probability Models
 - Data/Quantification Issues



PRA Parameters

- Initiating Event Frequencies
- Basic Event Probabilities
 - Hardware
 - component unreliability (fail to start/run/operate/etc.)
 - component unavailability (test or maintenance)
 - Human Errors (discussed later)
 - Common Cause Failures (already discussed)



Initiating Events (for NPP PRAs)

- Typically, only parameter in PRA that is quantified as a frequency
 - General Transients
 - with and without main feedwater
 - LOCAs
 - pipe breaks and stuck open PORVs and SRVs
 - Containment Bypass Event
 - SGTRs and ISLOCAs
 - Support System Failures
 - ac & dc power, SWS, CCW, instrument air



Initiating Event Data

- Typically combination of:
 - Generic data for rare events (e.g., LOCAs)
 - Plant-specific data for more common events (most transients)
- NUREG/CR-5750
 - Contains both plant-specific and industry-wide estimates
 - Three versions available
 - Original: Feb. 1999 (1987-1995)
 - Draft update issued: Mar. 2000 (1987-1998)
 - Electronic data and results updated through 2010
 - http://nrcoe.inel.gov/results/
- NUREG/CR-6928 (January 2007) contains industry-average rates for initiating events and components (used in SPAR models).



Non-IE Basic Events are Probabilities

- Probability of failure depends on the failure rate (i.e., the λ or p) and the mission time
 - Typically modeled as either Poisson or Binomial
 - Unavailability (e.g., T&M) calculated directly as a probability
 - However, T&M unavailability can be estimated as an unreliability (like binomial) as well
- Key feature (of data) is that the set of failure events and set of demands (or time) must be consistent with each other



Component Failure Rate Estimates

- Point Estimate
 - Demand Failures, Q_d(1 demand) = [↑] = f/d
 f = total number of demand failures
 d = total number of demands
 - Time related failures
 - Running failure rate, $\hat{\lambda}_r = f_r/t_r$ $f_r = \text{total number run failures}$ $t_r = \text{total number run hours}$
 - Standby failure rate, $\hat{\lambda}_s = f_s/t_s$ $f_s = \text{total number standby failures}$ $t_s = \text{total number hours in standby}$
 - Unavailability due to T or M (both scheduled and unscheduled), $Q_{TM} = t_d/t_t = down-time/total-time = time out of service/total-time$
 - Probability distribution (density functions) on λ 's generated using Bayesian methods



Failure Probability Models

- Demand Failures
 - Binomial: prob(r failures in n demands) $= \binom{\mathbf{n}}{\mathbf{r}} p^{r} (1-p)^{n-r}$ prob(1 failure|1 demand) = p = Q_d
- Failures in Time
 - Poisson: prob(r failures in time t) = $\frac{(\lambda t)^r e^{-\lambda t}}{r!}$ prob(r >0, in time t) = 1-e^{-\lambda t} \approx \lambda t (for \lambda t < 0.1)

$$\binom{\mathbf{n}}{\mathbf{r}}$$
 = n!/(r!(n-r)!) = number of ways n items can be grouped r at a time



Bayesian Methods Employed to Generate Uncertainty Distributions

- Two motivations for using Bayesian techniques
 - Generate probability distributions (classical methods generally only produce uncertainty intervals, not pdf's)
 - Compensate for sparse data (e.g., no failures)
- In effect, Bayesian techniques combine an initial estimate (prior) with plant-specific data (likelihood function) to produce a final estimate (posterior)
- However, Bayesian techniques rely on (and incorporate) subjective judgement
 - different options for choice of prior distribution (i.e., the starting point in a Bayesian calculation)



Bayesian Technique Starts With Subjective Judgment

- Prior represents one's belief about a parameter before any data have been "observed"
- Prior can be either informative or non-informative
 - Three common priors
 - Non-informative (Jeffreys) prior
 - Informative prior (e.g., generic data)
 - Constrained non-informative prior



Non-Informative Prior

- Imparts little prior belief or information
- Minimal influence on posterior distribution
 - Except when updating with very sparse data
- Basically assumes 1/2 of a failure in one demand (for binomial, or in zero time for a Poisson process)
 - If update data is very sparse, mean of posterior will be pulled to 0.5

E.g.: for plant-specific data of 0/10 (failures/demands)

Update=> 0.5/1 (prior) + 0/10 (likelihood) => 0.5/11 (posterior)



Informative Prior

- Maximum utilization of <u>all</u> available data
- Prior usually based on generic or industry-wide data
- Avoids potential conservatism that can result from use of noninformative prior
- However, good plant-specific data can be overwhelmed by a large generic data set

```
e.g., prior = 100/10000 (failures/demands) = 1E-2
plant-specific = 50/100 (failures/demands) = 0.5
posterior = 150/10100 = 1.5E-2 (basically the prior)
```



Constrained Non-informative Prior

- Combines certain aspects of informative and non-informative priors
 - Weights the prior as a non-informative (i.e., 1/2 of a failure)
 - However, constrains the mean value of the prior to some genericdata based value
- For example generic estimate of previous example would be "converted" to a non-informative prior

```
100/10000 => 0.5/50 (this then used as the prior)
```

Update=>
$$0.5/50 + 50/100 => 50.5/150 = 0.34$$



Other Update Methods and Priors Exist

For Example:

Empirical Bayes Method Hierarchical Bayes Method "Two-Stage" Bayesian Method Maximum entropy priors Non-Conjugate priors

System Modeling Techniques for PRA

Lecture 10 - Overview of Human Reliability Analysis for PRA





Objectives

- Understand Human Reliability Analysis (HRA) as an input to PRA
- Understand basic philosophies and techniques in HRA modeling
- Outline
 - HRA Process
 - Performance Shaping Factors
 - Human Error Categorization and Quantification
 - HRA modeling concerns



Human Reliability Analysis

- Objective
 - Provide input to PRA regarding likelihood of human failure events
- PRA-Based Classification of Human Error (HE)
 - Pre-initiator (latent)
 - Initiating event
 - Post-initiator (dynamic)
 - Recovery
- Contribution from some HE's already accounted for in hardware failure data
 - Typically PRA only includes:
 - Post-initiator actions (i.e., operator responses guided by emergency operating procedures)
 - Recovery actions



HRA Process

- Identify relevant human actions/errors
 - Necessary actions
 - Responses to situation
- Identify influences that affect human performance (both positively and negatively)
 - Stress, time available, training, etc.
- Quantify human error probability
 - Various techniques available



Human Error Identification

- Two basic roles modeled in PRA
 - Human as an integral part of plant response
 - Human as the "fixer" of failures
- Sometimes include human as the source of failures.
 - Very problematic how to identify all the mistakes the human operator might make?
- Two general types of human errors
 - Errors of Omission (EOO)
 - Operator fails to accomplish a needed action
 - Errors of Commission (EOC)
 - Operator successfully accomplishes an incorrect action
 - Sometimes segregated into cognitive and non-cognitive EOCs
 - Was it the operators intention to perform the (incorrect) action?



Typical Roles Modeled in PRA

- Human as integral part of system
 - Basically, procedure follower
 - "Operator fails to perform required action"
 - Errors of omission
- Human as performer of recovery action
 - "Operator fails to manually initiate injection given failure of automatic actuation"
 - Errors of omission
- Errors of commission seldom modeled
 - Lack of basis for postulating a specific EOC
 - Potential number of EOCs virtually unlimited
 - How do you identify all the inappropriate actions a person might do?



Influences on Human Performance

- Circumstances that might enhance or reduce the likelihood of a human error
- What specific aspect of event context mostly affect the likelihood of the human error
 - General environment
 - Safety culture, training, job aids, etc.
 - Individual/team
 - Education, aptitude, cooperation, etc.
 - Specific situation
 - Procedures, instrumentation, task aids, etc.
- Referred to as: Performance Shaping Factors (PSFs)
- Every Human Reliability Analysis technique has it's own unique list



Common HRA Methods

- Technique for Human Error Rate Prediction (THERP)
- Accident Sequence Evaluation Program (ASEP) HRA Procedure
- Human Cognitive Reliability (HCR)/Operator Reliability Experiments (ORE) Method
- Cause-Based Decision Tree (CBDT) Method
- Electric Power Research Institute (EPRI) HRA Calculator®
- Standard Plant Analysis Risk HRA (SPAR-H) Method
- A Technique for Human Event Analysis (ATHEANA)
- Success Likelihood Index Methodology (SLIM) Multi-Attribute Utility Decomposition (MAUD)
- Failure Likelihood Index Methodology (FLIM)
- A Revised Systematic Human Action Reliability Procedure (SHARP1)



Timeline of HRA Methods

CD's First Released



Return of Halley's Comet



Hubble **Telescope** Launched



Existence of

Black_ Holes Proven **Olympic Games Atlanta**

First Balloon **Trip Around** the World



Today

ASP/SPAR

(1994)

ASEP (1987)

Simplified THERP

HEART (1986)

SHARP (1984)

HRA

Framework HCR

(1984)

First HCR

SLIM-**MAUD** (1984)

SHARP1 (1991)

Revised

Framework

ORE (1989)

Operator Reliability

Experiments

CBDTM (1992)

Cause-Based

Decision **Trees**

ATHEANA

ATHEANA (1996)(Rev.1

> 2000) **SPAR-H** (2005)

CREAM (1998)

NARA (2004)

CAHR (1999)

MERMOS

(1998)**EPRI (2000)**

HRA Users Group



PSFs Used in ATHEANA

- Applicability and Suitability of Training/Experience
- 2. Suitability of Relevant Procedures and Administrative Controls
- 3. Operator Action Tendencies and Informal Rules
- 4. Availability and Clarity of Instrumentation (Cues to Take Actions and Confirm Expected Plant Response)
- 5. Time Available and Time Required to Complete the Act, Including the Impact of Concurrent and Competing Activities
- 6. Complexity of the Required Diagnosis and Response, the Need for Special Sequencing, and the Familiarity of the Situation
- 7. Workload, Time Pressure, and Stress
- 8. Team/Crew Dynamics and Crew Characteristics [Degree of Independence Among Individuals, Operator Attitudes/Biases/Rules, Use of Status Checks, Approach for Implementing Procedures (e.g., Aggressive Crew vs. Slow/Methodical Crew)]
- Available Staffing/Resources
- 10. Ergonomic Quality of the Human-System Interface (HSI)
- Environment in Which the Action Needs To Be Performed
- 12. Accessibility and Operability of the Equipment To Be Manipulated
- 13. Need for Special Tools (Keys, Ladders, Hoses, Clothing Such as To Enter a Radiation Area)
- 14. Communications Strategy and Coordination, and Whether One Can Be Easily Heard
- 15. Special Fitness Needs
- 16. Realistic Accident Sequence Diversions and Deviations (e.g., Extraneous Alarms, Outside Discussions, or Sequence Evolution Not Exactly Like That on Which Operators Are Trained)



Quantification -Two Levels

- Conservative (screening) level useful for determining which human errors are most significant contributors to overall system error
- Those found to be potentially significant contributors can be analyzed in greater detail (which often lowers the HEP)
 - These revised HEP are then put back into the PRA



Different Techniques View Human Errors Differently

- Classification Approaches
 - Omission/Commission
 - Skill/Rule/Knowledge
 - Slip/Lapse/Mistake/Circumvention
- Decomposition Approaches
 - None (e.g., Time-Based Methods)
 - Functional (e.g., detection/diagnosis/decision and action)
 - Task-based



Estimating Human Error Probability (HEP)

- Classification of Human Error provides starting point for quantification
 - Typically, HRA method provides a library of Base Human Error Probabilities (BHEPs)
- BHEP is then modified to include effects of PSFs.
 - Each PSF evaluated to determine effects on estimated HEP
 - HRA method will provide guidance on how to scale BHEPs to produce final HEP

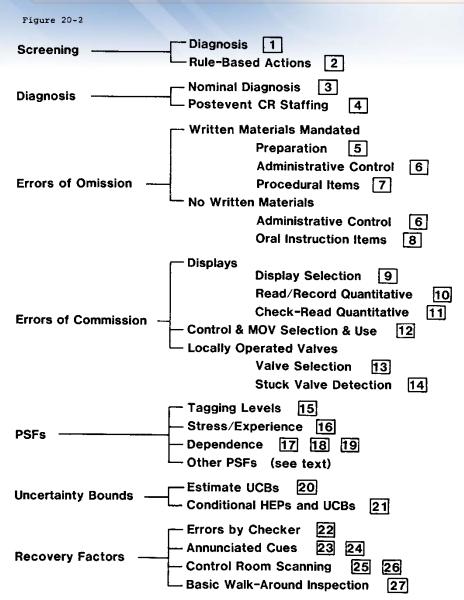


Example Classification Scheme

		Action Type			
		Skill	Knowledge	Rule	
	Omission				
Error	Commission (Cognitive)				
Type	Commission (Non- Cognitive)				



Directory of THERP Tables for Quantification of Human Errors (NUREG/CR-1278)







Example THERP Table

(Procedural Items - 7)

Table 20-7 Estimated probabilities of errors of omission per item of instruction when use of written procedures is specified* (from Table 15-3)

Item**	Omission of item:	HEP	EF
	When procedures with checkoff provisions are correctly used:		
(1)	Short list, ≤10 items	.001	3
(2)	Long list, >10 items	.003	3
	When procedures without checkoff provisions are used, or when checkoff provisions are incorrectly used ::		
(3)	Short list, ≤10 items	.003	3
(4)	Long list, >10 items	.01	3
(5)	When written procedures are available and should be used but are not used	.05 [‡]	5

The estimates for each item (or perceptual unit) presume zero dependence among the items (or units) and must be modified by using the dependence model when a nonzero level of dependence is assumed.

The term "item" for this column is the usual designator for tabled entries and does not refer to an item of instruction in a procedure.

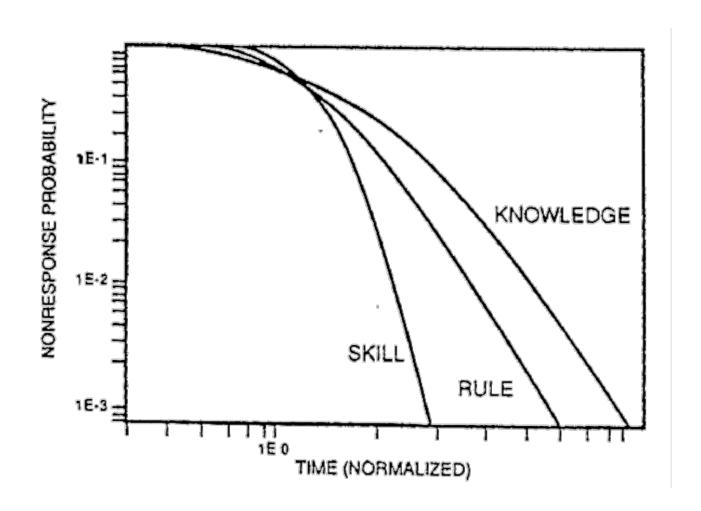
^{**}Correct use of checkoff provisions is assumed for items in which written entries such as numerical values are required of the user.

^{††}Table 20-6 lists the estimated probabilities of incorrect use of checkoff provisions and of nonuse of available written procedures.

If the task is judged to be "second nature," use the lower uncertainty bound for .05, i.e., use .01 (EF = 5).



HCR Model Categorizes Actions as Knowledge, Rule or Skill Based





SPAR-H (NUREG/CR-6883)

- The SPAR HRA, or SPAR-H, method was developed at the INL to support the NRC
- SPAR-H is a simplified approach based on THERP
 - HEPs in SPAR-H derived from THERP
 - Approach uses performance shaping factors (PSFs) instead of sample scenarios, making it easier to generalize
- Base HEP for SPAR-H is:
 - Diagnosis = nominal value of 1.0E-2
 - Action = nominal value of 1.0E-3





SPAR-H Quantification

- SPAR-H Worksheets are used to quantify HEPs by considering factors (PSFs) that may increase/decrease likelihood of error
 - Available time.
 - Complexity
 - Procedures
 - Fitness for duty
 - Stress/stressors
 - Experience/training
 - Ergonomics/HMI
 - Work Processes

Example: Available Time

- inadequate time → p(failure) = 1.0
- barely adequate time \rightarrow p(failure) = HEP x 10
- nominal time → p(failure) = HEP x 1
- extra time $\rightarrow p(failure) = HEP \times 0.1$
- expansive time \rightarrow p(failure) = HEP x 0.01



HRA Modeling Concerns

- HRA is intended to be a prospective analysis aimed at predicting the occurrence and likelihood of human errors during some possible future event
 - Unlike hardware failures, which are statistically quantified, human errors are modeled "contextually"
 - Context is characterized, then the probability is estimated (typically using engineering judgment)
 - How well can the context for some future potential accident be characterized?
 - What are all the influences (PSFs) that might (will?) affect the performance of the operator?



HRA Modeling Concerns (cont.)

- HRA data is very limited
 - Little experience data available
 - THERP is based on 1960's data from assembling nuclear weapons
 - HCR based on simulator experiments
 - Operators are expecting something to happen
 - Would operators really perform the same in an actual emergency situation?

System Modeling Techniques for PRA

Lecture 11 - Risk Assessment Results





Objectives

- Be able to understand typical PRA results
- Understand value and limitations of importance factors
- Outline
 - Dominant Contributors
 - Importance Measures



Sample Summary Level 1 Results

Plant	Study Sponsor	Method	No. of Dominant Sequences	%CDF
Beaver Valley 2	Utility	ET/BC	12	42
Brunswick 1	Utility	Linked FT	10	95
Brunswick 2	Utility	Linked FT	10	95
Dresden	Utility	ET/BC	10	95
Farley	Utility	ET/BC	19	35
FitzPatrick	Utility	ET/BC	9	87
Grand Gulf	USNRC	Linked FT	3	96
La Salle	USNRC	Linked FT	5	95
Oyster Creek	Utility	ET/BC	10	51
Peach Bottom	USNRC	Linked FT	11	95
Sequoyah	USNRC	Linked FT	15	95
Surry	USNRC	Linked FT	20	95
Zion	USNRC	ET/BC	13	95



Sample Summary Level 1 Results

Surry (NUREG-1150) Westinghouse PWR

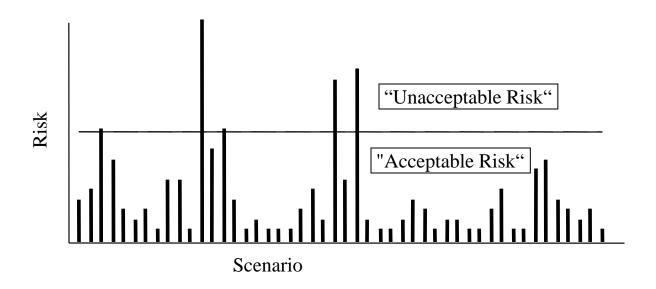
Grand Gulf (NUREG-1150) BWR

Seq	Description	% CDF	Cum	Seq	Description	% CDF	Cum
1	Station Blackout (SBO) - Batt Depl.	26.0	26.0	1	Station Blackout (SBO) With HPCS And RCIC Failure	89.0	89.0
2	SBO - RCP Seal LOCA	13.1	39.1	2	SBO With One SORV, HPCS And RCIC Failure	4.0	93.0
3	SBO - AFW Failure	11.6	50.7	3	ATWS - RPS Mechanical Failure With MSIVs Closed,	3.0	96.0
4	SBO - RCP Seal LOCA	8.2	58.9		Operator Fails To Initiate SLC, HPCS Fails And		
5	SBO - Stuck Open PORV	5.4	64.3		Operator Fails To Depressurize		
6	Medium LOCA - Recirc Failure	4.2	68.5				
7	In terfa cing LOCA	4.0	72.5				
8	SGTR - No Depress - SG Integ'ty Fails	3.5	76.0				
9	Loss of MFW/AFW - Feed & Bleed Fail	2.4	78.4				
10	Medium LOCA - Injection Failure	2.1	80.5				
11	ATWS - Unfavorable Mod. Temp Coeff.	2.0	82.5				
12	Large LOCA - Recirculation Failure	1.8	84.3				
13	Medium LOCA - Injection Failure	1.7	0.68				
14	SBO - AFW Failure	1.6	87.6				
15	Large LOCA - Accum ulator Failure	1.6	89.2				
16	ATWS - Em ergen cy Boration Failure	1.6	90.8				
17	Very Small LOCA - Injection Failure	1.5	92.3				
18	Small LOCA - Injection Failure	1.1	93.4				
19	SBO - Battery Depletion	1.1	94.5				
20	SBO - Stuck Open PORV	0.8	95.3				



Dominant Contributors

- Implications
 - Typically small number of scenarios
 - Can concentrate on a small number of issues
 - As outliers are addressed, more scenarios become the "important" contributors





Dominant Contributors

- Contributors to risk can be identified at many levels
 - Initiating events (e.g., LOCA)
 - Sum of all CD sequences with particular IE
 - Accident sequences (e.g., S5 = LOCA * AUTO * /MAN * /ECI * ECR)
 - Minimal cut sets (e.g., ECI = PS-A * PS-B)
 - Failure causes (e.g., CCF of PS-A and PS-B)



What are Importance Measures

- A means of utilizing a PRA model to measure impact of model inputs on total risk
 - An effective way to separate, identify, & quantify values of individual factors which affect risk
 - Design features
 - Plant operations
 - Test & maintenance
 - Human reliability
 - System & component failures



Importance Measures

- Provide quantitative perspective on dominant contributors to risk and sensitivity of risk to changes in input values
- Usually calculated at core damage frequency level
- Common importance measures include:
 - Fussell-Vesely
 - Risk Reduction or Risk Reduction Worth
 - Risk Increase or Risk Achievement Worth (RAW)
 - Birnbaum



Fussell-Vesely (FV)

- Measures the overall percent contribution of cut sets containing a basic event of interest to the total risk
- Calculated by finding the value of cut sets that contain the basic event of interest (x_i) and dividing by the value of all cut sets representing the total risk

$$FVx_i = F(i) / F(x)$$
 or alternate equations
$$FVx_i = [F(x) - F(0)] / F(x) = 1 - F(0) / F(x) = 1 - 1/RRRx_i$$
 where,

- F(x) is the total risk from all cut sets with all basic events at their nominal input value
- F(i) is the total risk from just those cut sets that contain basic event x_i
- F(0) is the total risk from all cut sets with basic event of interest (x_i) set to 0
- The FV range is from 0 to 1 (0% to 100%)
 - Example: If a basic event such as check valve A (CVA) appears in minimal cut sets contributing 2×10^{-6} to CDF and the total CDF from all minimal cut sets is 1×10^{-5} , then the FV_{CVA} = $(2\times10^{-6})/(1\times10^{-5})$ = 0.2 (20%)



Risk Reduction Importance (Risk Reduction Worth)

- Measures the amount that the total risk would decrease if a basic event's input value were 0 (i.e., never fails)
- Calculated as either ratio or difference between the value of all cut sets representing the total risk with all basic events at their nominal input value and the value of the total risk with the basic event of interest (x_i) set to 0
 - Ratio: $RRRx_i = F(x) / F(0)$
 - Difference (or Interval): RRIx_i = F(x) F(0)
 where,
 - F(x) is the total risk from all cut sets with all basic events at their nominal input value
 - F(0) is the total risk from all cut set with basic event of interest (xi) set to 0
- The Risk Reduction Ratio range is from 1 to ∞
- Risk Reduction gives the same ranking as Fussell-Vesely
- For Maintenance Rule (10 CFR 50.65), NUMARC Guide 93-01 (endorsed by NRC) uses a RRR significance criterion of 1.005 (which is equivalent to Fussell-Vesely importance of 0.005)
 - Example: If a basic event such as check valve A (CVA) results in a CDF of 3×10⁻⁶ when not failed and total CDF from all minimal cut sets is 1×10⁻⁵, then the RRRCVA= (1×10⁻⁵)/(3×10⁻⁶) = 3.33



Risk Increase Importance (Risk Achievement Worth)

- Measures the amount that the total risk would increase if a basic event's input value were 1 (e.g., component is failed or taken out of service)
- Calculated as either ratio or difference between the value of the total risk with the basic event of interest (xi) set to 1 and the total risk with all basic events at their nominal input value
 - Ratio: RAW x_i or RIR x_i = F(1) / F(x)
 - Difference (or Interval): RIIx_i = F(1) F(x) where,
 - F(x) is the total risk from all cut sets with all basic events at their nominal input value
 - F(1) is the total risk with basic event of interest (x_i) set to 1
- Ratio measure referred to as Risk Achievement Worth (RAW)
- The RAW range is ≥ 1
- For Maintenance Rule (10 CFR 50.65), NUMARC Guide 93-01 (endorsed by NRC) uses a RAW significance criterion of 2
 - Example: If a basic event such as check valve A (CVA) results in a CDF of 2×10^{-5} when failed and the total CDF from all minimal cut sets is 1×10^{-5} , then the RAW_{CVA}= $(2\times10^{-5})/(1\times10^{-5}) = 2$



Birnbaum (B)

- Measures the rate of change in total risk as a result of changes to the input value of an individual basic event
- Ranks events according to the effect they produce on the risk level when they are modified from their nominal values
 - $B_x = \partial F(x) / \partial x$ where,
 - F(x) is the total risk from all cut sets with all basic events at their nominal input value
 - $\partial/\partial x$ is the first derivative of the risk expression with respect to the basic event of interest (x_i)
- When the risk expression has a linear form
 - $B_{xi} = F(1) F(0)$ where,
 - F(1) is the total risk with basic event of interest (x_i) set to 1
 - F(0) is the total risk from all cut set with basic event of interest (x_i) set to 0
- The B range is between 0 and the cumulative initiating event frequency (i.e., B = 0 indicates little risk sensitivity and B = cumulative initiating event frequency indicates large risk sensitivity)
 - Example: If a basic event such as check valve A (CVA) results in a CDF of 3×10^{-6} when not failed and results in a CDF of 2×10^{-5} when failed, then the B_{CVA}= (2×10^{-5}) (3×10^{-6}) = 1.7×10^{-5}



Application Notes

- Relations between measures
 - $FV = 1 1/RRR_i$
 - $Br_i \cong F_i(1) = F(x) + RII_i$ [if $F_i(0) << F_i(1)$]
- Measures can be computed for systems and components as well as basic events
 - Concerns about how to computationally generate these (i.e., importance measures generally do not "add" due to overlap between cut sets)

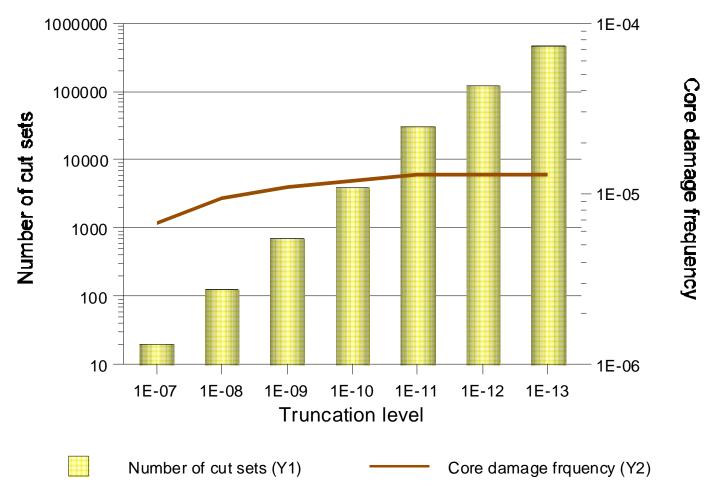


Application Notes (cont.)

- Cautions
 - Improper/misleading labeling of basic events
 - Exclusion of components not in model (e.g., passive components)
 - Parameter values used for other events in model
 - Inconsistent levels of conservatism among BE probabilities can skew ranking
 - Present configuration of plant (equipment that is already out for test/maintenance)
 - Model truncation during quantification and the affect on Birnbaum and RAW

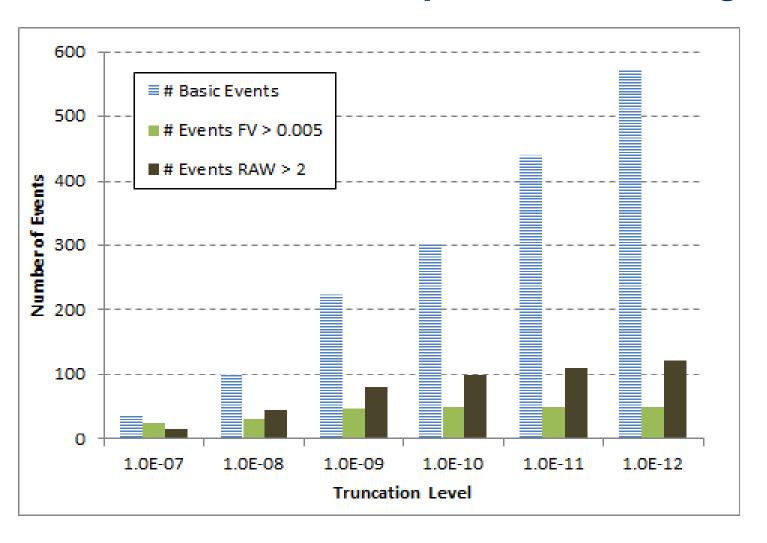


Core Damage Frequency and Number of Cut Sets Sensitive to Truncation Limits





Truncation Limits Affect Importance Rankings



System Modeling Techniques for PRA

Lecture 12 - Special Topics





Objectives

- General understanding of special topics and issues associated with PRA
- Outline
 - Recovery Analysis
 - Level 2 and Level 3
 - Aging
 - External Events



Recovery Analysis Required for Realistic Estimate of Risk

- Options are typically available to control room operators for recovering from component/system failures
 - Manually actuating equipment
 - Re-aligning flow around failed equipment
 - Cross-tie systems from "other" unit
 - Utilizing non-safety grade equipment
- Typically quantified using detailed HRA



Recovery Analysis (cont.)

- Ideally treated at cut set specific level
- Specific set of basic events (in cut set) examined to identify potential recover actions
 - Incorporating into system models usually not a good idea (can create situations of multiple recovery actions in same scenario; can result in impossible recovery actions)
- Recovery possibilities can depend on specific failure modes and mechanisms
 - e.g., HPI MDP fails to start due to actuation failure, can be recovered via manual start (mechanical FTS might not be recoverable)



Level 2/3 Analysis

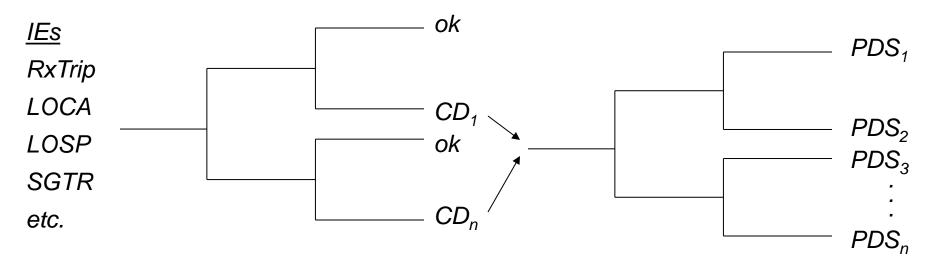
- Level-1 accident sequences analysis typically quantifies core damage frequency (CDF)
- Containment analysis (Level 2) and consequence analysis (Level 3) usually performed "separate" from CDF analysis
- Method needed to link accident sequence analysis to containment analysis



Expanded Systems Analysis Needed to Support Level-2 Model

IE Level-1 Event Tree

Bridge Event Tree Appends Containment Systems to Level-1 ET





Bridge Event Trees

- Additional system models and analyses needed before containment analysis can be performed
 - "Core Damage" result, not adequate for starting containment analysis
 - Containment system models need to be integrated with Level 1 system analysis (i.e., need to capture dependencies)
 - Bridge Event Tree (BET) used to model additional systems/phenomena, linked to Level 1 event trees
 - Typically generates Plant Damage State (PDS) vectors



Plant Damage States

- Output (end states) of BET defined in terms of specific details on CD accident sequence
- Method utilizes a vector framework
 - e.g., ACCBABDC
 - Each character identifies the status of a particular system or event
 - Vector is "read" by the Level 2 analysis



Example Plant Damage State Vector Framework

Character	PWR	BWR
1	Status of RCS at onset of core damage	Status of RPS
2	Status of ECCS	Status of electric power
3	Status of containment heat removal	RPV integrity
4	Status of electric power	RPV pressure
5	Status of contents of RWST	Status of HPI
6	Status of heat removal from S/Gs	Status of LPI
7	Status of cooling for RCP seals	Status of containment heat removal
8	Status of containment fan coolers	Status of containment venting
9		Level of pre-existing leakage from containment
10		Time to core damage



Palisades IPE PDS Characteristics

# Characteristic	Description
1 Initiator	Affects potential for containment bypass, fission product retention by the RCS, pressure of the RCS at
	vessel failure, etc.
2 CD Time	Time of fission product release and amount of warning time for offsite protective actions.
3 Secondary Cooling	Can affect late revaporization of fission products retained in the RCS
4 Pressurizer PORV	Affects RCS pressure during the core relocation/vessel failure phase of a CD sequence
5 Containment Systems	Affect long term integrity of containment. Can affect debris coolability, flammable gas behavior, fission product releases



Palisades IPE PDS Character #1 (Initiator)

ID Description

- A1 Large LOCA (d > 18 in.)
- A2 Medium LOCA (2 in. < d < 18 in.)
- B Small LOCA (1/2 in. < d < 2 in.)
- C Interfacing System LOCA
- D SGTR
- T Transient



Palisades IPE PDS Char. #'s 2, 3 & 4

2	Core Damage Timing	
Ε	Early CD	
L	Late CD	
3	Secondary Cooling	
G	Secondary Cooling Available	
J	No Secondary Cooling	
4	Pressurizer PORV	
M	PORV Available	
Ν	PORV Unavailable	



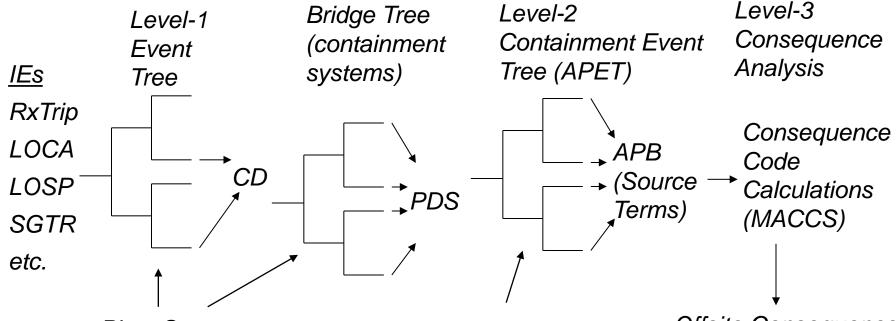
Palisades IPE PDS Char. #5 (Containment Systems)

ID Description

- P Containment sprays and air coolers available
- Q Cont. sprays avail. and cont. air coolers NOT avail.
- R Only cont. air coolers avail., RWST contents in cont.
- S Only cont. air coolers avail., RWST contents NOT in cont.
- V No cont. systems avail., RWST contents in cont.
- W No cont. systems avail., RWST contents NOT in cont.
- X Late (post VB) operation of only HPSI/LPSI



Overview of Level-1/2/3 PRA



Plant Systems and Human Action Models (Fault Trees and Human Reliability Analyses)

Severe Accident
Progression
Analyses
(Experimental and
Computer Code
Results)

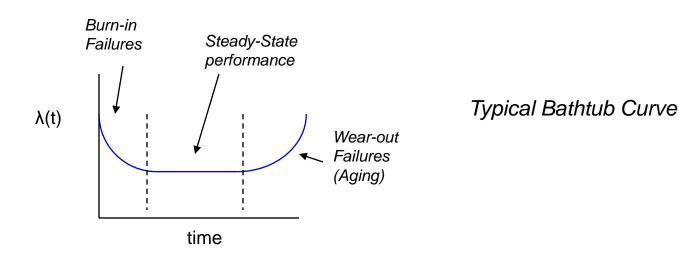
Offsite Consequence Risk

- Early Fatalities/year
- Latent Cancers/year
- Population Dose/year
- Offsite Cost (\$)/year
- etc.



Aging

- Not accounted for in vast majority of PRAs/IPEs
- System is no longer memoryless
 - Violation of Poisson assumption; failure rate is not constant (termed "hazard function")
 - Failure rate is time dependent





Aging (cont.)

- Given λ(t) quantification is straightforward
 - Failure rate changes only affect numerical values in fault tree, not structure
 - Failure rate usually changes slowly enough that time-dependent effects are not important during accident
- Aging is particularly of interest for passive components
 - Active components are maintained and sometimes replaced
 - Passive components are often left out of the analysis because of their initially low failure rates



Aging (cont.)

• Estimation of $\lambda(t)$: some work suggests that a linear aging model is reasonable

$$\lambda(t) = a + b \cdot t$$

- Alternatively, physical models for component behavior can be used
 - i.e., explicitly accounting for physical aging mechanisms



External Events Analysis

Objective

- Estimate risk contribution due to "external events"
- Events modeled typically include:
 - Seismic events
 - Area events
 - Fires
 - Floods (internal and external)
- Require detailed plant layout information

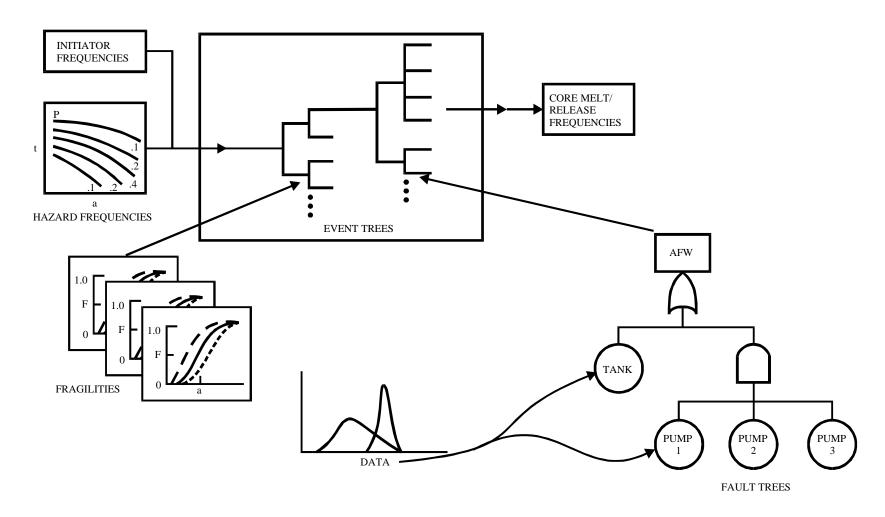


External Events Analysis (Seismic)

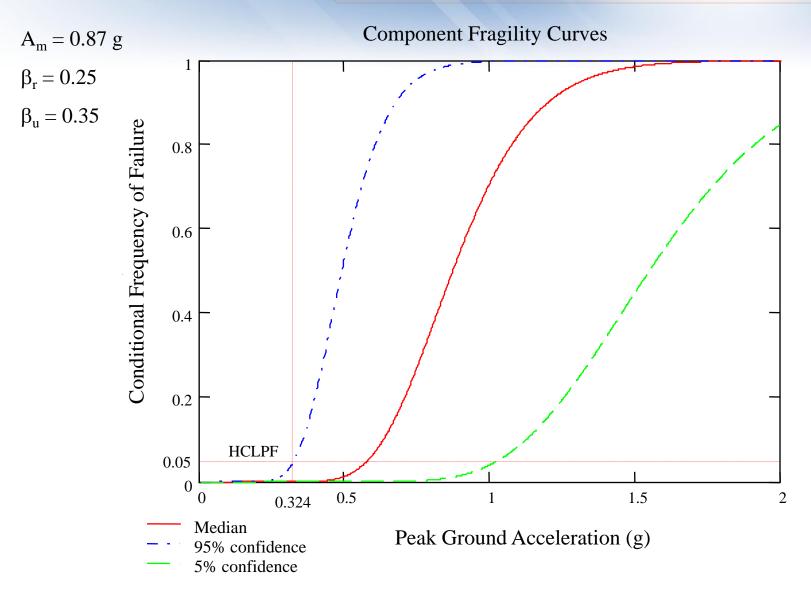
- Seismic events analysis requires 3 basic steps
 - Hazards analysis (frequency-magnitude relationship for earthquakes)
 - Location-specific hazard curves produced by NRC (LLNL) and EPRI
 - New Curves related by USGS in 2014
 - Fragility analysis ("strength" of components)
 - Conditional probability of failure given a specific earthquake severity
 - Accident sequence analysis



External Events Analysis (Seismic)









External Events Analysis (Area)

- Spatially coupled events analysis requires 4 basic steps
 - Spatial interactions analysis
 - Frequency analysis
 - Damage analysis
 - Accident sequence analysis

System Modeling Techniques for PRA

Appendix A – Workshops





Probability and Frequency

- 1. An event occurs with a frequency of 0.02 per year.
 - 1.1. What is the probability that an event will occur within a given year?
 - 1.2. What is the probability that an event will occur during the next 50 years?
- 2. Event A occurs with a frequency of 0.1 per year. Event B occurs with a frequency of 0.3 per year.
 - 2.1. What is the probability that an event (either A or B) will occur during the next year?
 - 2.2. What is the probability that an event (either A or B) will occur during the next 5 years?
- 3. An experiment has a probability of 0.2 of producing outcome C.
 - 3.1. If the experiment is repeated 4 times, what is the probability of observing at least one C?
 - 3.2. This same experiment has a probability of 0.4 of producing outcome D; however, if C occurs, then the probability of outcome D on the next trial is 0.6 (probability of C remain unchanged at 0.2). If the experiment is repeated (i.e., performed twice), what is the probability of at least one D?



Useful Values for Workshops

$$e^{-0.02} = 0.9802$$

$$e^{-0.10} = 0.9048$$

$$e^{-0.30} = 0.7408$$

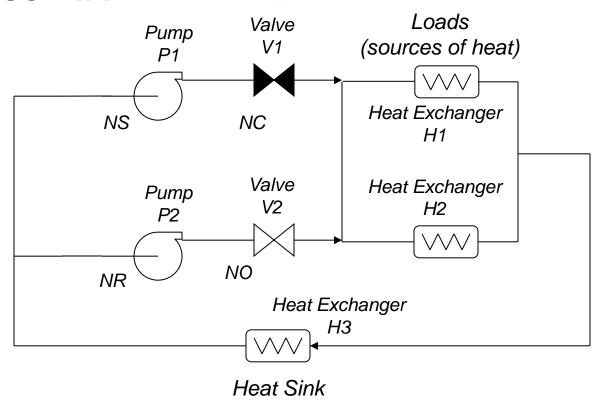
$$e^{-0.50} = 0.6065$$

$$e^{-1.00} = 0.3679$$

$$e^{-1.50} = 0.2231$$



Fault Tree - #1



Closed loop cooling system cools loads via heat exchangers H1 and H2. Heat is then remove from system through heat exchanger H3. System successfully performs its function when heat is absorbed through both H1 and H2, and expelled through H3, with flow maintained by either pump P1 or P2.





Motor Operated Valve – Normally Closed (requires ac power to operate).



Motor Operated Valve - Normally Open (requires ac power to operate).



Motor Operated Pump



Air Operated Valve – Normally Open (requires dc power and compressed air to operate, however typically will move to the "safe" position on loss of either).



Air Operated Valve – Normally Closed (requires dc power and compressed air to operate, however typically will move to the "safe" position on loss of either).



Manually Operated Valve – Normally Open (operates using a handwheel or chain-wheel located on the valve itself).



Check Valve - Operates passively, allows flow in only one direction.

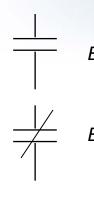


Water Tank – Typically source of water for system



Heat Exchanger – Used to transfer heat from one fluid system to another (i.e., connects two fluid systems in order for one system to cool the other





Electrical contacts or switch - Normally open (i.e., in "off" position)

Electrical contacts or switch - Normally closed (i.e., in "on" position)

Electrical coil or solinoid - Used to operate piece of equipment (e.g., a set of electrical contacts)

NS Normally Stopped

NR Normally Running

NC Normally Closed

NO Normally Open



Fault Tree - #2

- Cooling water pumps have the following support system dependencies:
 - AC power
 - Room cooling
 - Start signal
- Pump P1 is normally in standby and must be either automatically or manually started. When the pump is needed to start and run, an automatic actuation signal is sent to the pump. However, if the auto signal fails, the operators can manually start the pump. Also, room cooling is only required during the hot summer months of July and August. The rest of the year, room cooling is not needed. Lastly, the pump is made unavailable for eight hours, twice a year for maintenance.
- Successful operation requires the pump to start and run for 24 hours.
- Construct a fault tree for P1.

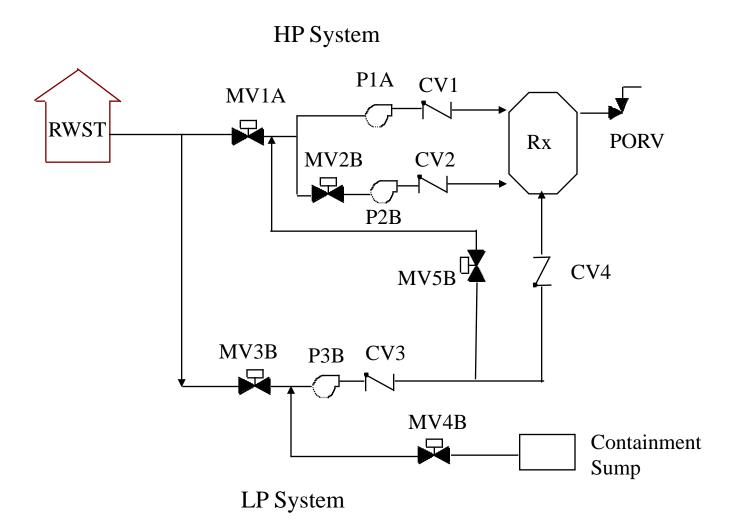


Data

Component	Failure Mode	Failure Rate
V - manual valve	fails to open (FTO)	5E-5/demand
P - motor driven pump	fails to run (FTR) fails to start (FTS)	3E-5/hr 3E-3/demand
ac – ac power	loss of power (LOP)	1E-7/hr
rm – room cooling	loss of room cooling (LOC)	1E-6/hr
H – heat exchanger	plug (PG)	1E-8/hr
ACT – Actuation	Manual fails (HE) Automatic fails (AU)	0.1/demand 0.01/demand



Simple Emergency Coolant Injection/Recirculation





Boundary Conditions

- 1. No equipment cooling requirements (room, lube oil, or seal)
- 2. No maintenance of equipment during plant operations, no partial actuation system failures
- 3. "A" components powered from ac bus A
- 4. "B" components powered from ac bus B
- Control power transformed from motive power for all valves (i.e., ignore control power dependencies for valves)
- Control power for pumps provided by respective dc buses, which in turn can be powered from either the same train ac bus or dedicated a battery
- 7. Power operated relief valve (PORV) can be manually opened from control room to depressurize the reactor vessel (Rx) and is powered from dc bus B
- 8. "A" train components actuated automatically by safety injection (SI) signal (powered by dc bus A)
- 9. "B" train components must be manually actuated (from control room)
- If high pressure (HP) system fails, operators can depressurize using PORV and cool reactor using the low pressure (LP) system
- 11. Success criteria for high pressure injection (HPI) is 1 of 2 pumps delivering flow to the reactor vessel (Rx).
- 12. System can operate in a total of four operating modes: HPI, low pressure injection (LPI), high pressure recirculation (HPR), and low pressure recirculation (LPR).
- 13. Ignore heat removal from LPR/HPR water.



Event Tree & Fault Tree Workshop

- 1. Only function required: Provide cooling to reactor vessel (Rx)
- Develop system-level event tree for small loss of coolant accident (SLOCA)
- 3. Generate core damage accident sequence logic
- 4. Develop fault trees for HPI, HPR, LPI and LPR.
- 5. Generate cut sets for HPI, HPR, LPI and LPR.
- 6. Generate core damage sequence cut sets